STUDY OF PHASE EQUILIBRIA IN THE SYSTEMS T1-As-S and T1-As-Se

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Westinghouse Research Laboratories

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A phase diagram study was conducted to determine the melting relations in portions of the chemical systems Tl-As-S and Tl-As-Se. Particular attention was paid to composition joins such as Tl₂S-As₂S₃, 1₁₂S-As₂S₅, Tl₂Se-As₂Se₃ and Tl₂Se-As₂Se₅, joins which include the ternary compounds Tl₃AsS₃, Tl₃AsS₄, rl₃AsSe₃, and Tl₃AsSe₄. These compounds melt congruently and are involved in pseudobinary phase relations along the above joins.

The phase diagram data were used to develop optimized crystal-growth

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compositions for the important ternary compounds. Crystal quality of Tl₃AsSe₃ and Tl₃AsS₄ was significantly improved during the contract period and crystals of Tl₃AsS₃ and Tl₃AsSe₄ grown for the first time. Observed features of the crystal growth were explained in terms of the observed phase relations.

Optical and Acousto-optical properties were determined for TlaAsSa, TlaAsSea, TlaAsSa, and TlaAsSea, and It is shown that there compounds have considerable potential as elements in optical and accuste-optical devices.

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1. INTRODUCTION

1.1 Objective

equilibria in the systems Tl-As-S and Tl-As-Se and a portion of the quaternary system Tl-As-S-se so as to optimize crystal growth of compounds in these systems, notably Tl₃AsS₃, Tl₃AsSe₃, and Tl₃AsS₄. These compounds form promising nonlinear optical and acousto-optical crysts²:. Optical techniques were to be used to evaluate crystal quality and the optical properties of any new compounds encountered were to be investigated to determine their potential as useful optical materials.

1.2 Background Information

Increasing interest is being shown in monlinear optical materials for harmonic generation and up-conversion applications in the infrared region of the spectrum. Sulfide-type materials are of special interest because they have a wide range of transparency and might be expected to transmit in the 10 µm region where oxides are usually opaque and where high power gas lasers operate. Only a few such materials, notably prountite (Ag₃AsS₃) and pyrargyrite (Ag₃SbS₃) were available in good optical quality prior to the start of the present program.

These two materials suffer from residual absorption at 10.6 µm, which causes deleterious heating effects when the high power densities at 10.6 µm necessary for efficient frequency conversion are used. Cinnabar (HgS) has suitably high nonlinear optical coefficients and a wide region of transporency (0.6 to 13 µm), but is very difficult to grow with good optical quality. Tellurium (Te) and selenium (Se) have been reported as nonlinear optical materials useful at 10.6 µm, but they also have poor optical quality. In addition, tellurium has been reported to exhibit an induced loss in SHG efficiency at 10.6 µm due to photoinduced carriers.

Sulfide-type materials are also of interest for acousto-optic applications. The technique of light deflection by acoustically generated gratings in solids or liquids is now well established, and many microwave and radio-frequency signal-processing devices have been constructed based on the acousto-optic interaction. The deflection efficiency of a material, or amount of light deflected from the incident beam for a given amount of acoustic power in the material is proportional to the so-called "accusto-optic figure of merit," $M_2 = \eta^6 p^2/\rho v^3$, where η is the refractive index of the material at the wavelength of the incident light, ρ is the photoelastic coefficient (which is roughly constant but may increase in regions of strong dispersion), ρ is the density, and v the acoustic velocity in the material.

It is evident that high refractive indices and low acoustic velocities are requirements for materials with large acousto-optic

figures of merit. Both are general properties of sulfide-type materials. Additional requirements on the usefulness of a given material are that it be optically transparent at the wavelength of light to be used in the application, and that it exhibit reasonably low acoustic loss at the acoustic frequencies to be used.

Prior to the inception of this contract the Westinghouse Research Laboratories had been actively searching for new sulfide-type materials for use as nonlinear and acousto-optic materials. Our experience in the area of nonlinear chalcogenides was derived from a thorough study of the phase relations and crystal growth of proustite and pyrargyrite. As a result of this survey, we had synthesized several T1-bearing chalcogenides that seemed promising for both nonlinear and acousto-optic applications. Of particular interest were the compounds T1₃AsS₃, T1₃AsSe₃, and T1₃AsS₄. These are close crystal-chemical relatives of Ag₃AsS₃ and Ag₃SbS₃ in that all belong to the sulfosalt class of chalcogenides.

Sulfosalts can be defined as having the general formula

ABC P

where A represents a metal, usually Ag, Cu, Hg, Pb, Tl, or Zn; B represents As, Bi, or Sb; and C represents S, Se, or Te. The B and C atoms in the general sulfosalt formula $A_m B_n C_p$ are almost always closely associated in the crystal structures, forming finite groups, rings, chains, or nets of BC₃ trigonal pyramids or BC₄ tetrahedra (with or

without additional C ions). Nowacki² classified all known sulfosalt minerals according to which of these structural units is present.

Perhaps a more convenient (but related) classification is by \$\phi\$ number, where

humber of C atoms | Humber of B atoms

For Tl_3AsSe_3 , $\phi = 3$; for Tl_3AsS_4 , $\phi = 4$, etc. The ϕ number of a particular sulfosult compound provides important information as to its crystal structure. For example, compounds with $\phi = 3$ typically contain isolated BC₃ tetrahedra as part of their structural makeup. Similarly, a crystal structure analysis will undoubtedly show this to be the case for Tl_3AsS_3 and Tl_3AsSe_3 as well.

We had obtained sufficient preliminary data on the melting relations of Tl₃AsSe₃ and Tl₃AsS₄ to show that both melted congruently, and crystals were grown using the techniques applied previously to Ag₃AsS₃. It was immediately evident that both were useful optical materials.

 Tl_3AsSe_3 had several advantages. It had the expected wide transmission range (1.5 to 15 µm) and, moreover, had decreased absorption loss relative to proustite and pyrargyrite. The refractive indices were high, indicating a high figure of merit for monlinear applications, and the birefringence was such as to allow phase matching for second-harmonic generation at 10.6 µm. It appeared that, in addition to second-harmonic generation, Tl_3AsSe_3 would also be useful

as a parametric oscillator pumped at wavelengths from 1.25 to beyond 10 μ m, and especially useful as a material for a 2 μ m pumped oscillator operating with outputs in the 3 to 5 μ m region.

Both Tl_3AsSe_3 and Tl_3AsS_4 were shown to be useful acousto-optic crystals. The acousto-optic figure of merit was measured, by direct comparison, for Tl_3AsSe_3 at $\lambda = 3.39~\mu m$, relative to fused silica at $\lambda = 0.6328~\mu m$. The relative figure of merit was measured as 955. This figure of merit is about twice as large as the figure of merit for germanium, the material presently being used in acousto-optic devices in the infrared region of the spectrum. Likewise, measurements of the figure of merit for Tl_3AsS_4 gave exceptionally high values at C 6328 μm , higher than any other known material.

It was also evident, however, that the crystal growth of these new materials would be difficult to optimize without a thorough knowledge of the melting relations in the applicable chemical systems. Only meager information was available for the ternary systems; in fact, many uncertainties and inconsistencies existed in the reported phase relations for the basic binary systems TI-S and TI-Se.

Our initial crystal growth efforts showed that the ideal chemical compositions were not the ideal growth compositions — the crystals almost invariably contained second-phase inclusions and/or cracked excessively. The program to study the phase diagrams for the systems Tl-As-S and Tl-As-Se was undertaken to understand and optimize the crystal growth of these Tl-containing sulfocalts.

1.3 General Approach

Approximately two thirds of the study was devoted to determining the melting relations of the important ternary compounds in the Ti-As-S and Tl-As-Se chemical systems. Particular attention was devoted to the detailed melting relations around the compounds Tl₃AsS₃, Tl₃AsSe₃, and Tl₃AsS₄. These phase relations were determined both by quenching experiments and by thermal heating and cooling curves. The data from the phase diagram study were then used to understand and optimize the crystal growth of the useful terwary compounds. Techniques for the passive and active evaluation of crystal quality were developed and applied to the optical-quality determination of the newly-grown crystals. Significant improvement is crystal quality was demonstrated and the improved crystals were measured to determine their device properties.

1.4 Summary

As a result of this program, we now have available extensive knowledge of melting relations in the systems Tl-As-S and Tl-As-Se. Optimized growth compositions were determined for Tl₃AsSe₃ and Tl₃AsS₄ and crystals of improved optical quality were grown. Optical measurements were performed that demonstrate the device potential of these compounds. Crystals of Tl₃AsS₃ and Tl₄AsS₄, were obtained showing considerable improvement over early grown efforts; we were not, however, able to obtain high quality rystals of Tl₄AsS₄. This is

explained on the basis of the determined phase diagrams. In the broader sense, data obtained in this study provide insight into the phase chemistry and crystal chemistry of this type of compound in general, information that should prove valuable in devising methods of approach leading to a thorough understant of other potentially useful chemical systems.

2. TECHNIQUES OF PHASE DIAGRAM STUDY AND CPYSTAL GROWTH

2.1 Techniques of Phase Diagram Study

Two techniques have been used for phase diagram study:

(2) quench-type or silica-tube experiments and (2) thermal analysis experiments. Both types of experiments are conducted in sealed, initially-evacuated, silica glass containers, which are well-suited for reactions among sulfide-type compounds because they are inert and because they constitute sealed containers for the volatile components such as sulfur and selenium.

Spectrographically analyzed Tl, As, S, and Se (each > 99.999 wt % purity) were used directly as reactants for both quench and thermal analysis expriments. The oxide coating that forms on Tl and As was removed by boiling the Tl in water and heating the As fragments in the reducing portion of a Bunsen-burner flame.

2.1.1 Quench Experiments

For quench-type experiments, reactant materials (typically 230 mg total weight) were carefully weighed in desired proportions, sealed in the containers, heated for lengths of time necessary to obtain equilibrium phase assemblages, and then chilled to room temperature. Phases were identified using standard microscope and x-ray techniques.

Some degree of experience is necessary to identify the stable phase assemblages at the heating temperatures by examination of the quenched products. For example, the presence of liquid in an experiment was indicated by the globular appearance of the charge after heating and by texture relations in polished specimens. Liquids generally crystallized during the quench to polyphase matter in which the individual phases (often displaying dendritic habit) could only be identified using high-magnification microscope lenses. The rate of quench-crystallization of liquids to such intergrowths decreases toward the As-S or As-Se side of both systems and, in the As₂S₃-rich or As₂Se₃-rich portions, liquids could be chilled as glasses.

Hany of the data presented below were obtained from melting point experiments. In a typical melting point determination, a poztion of presynthesized compound (e.g., Tl₃AsSe₃) or a mixture of compounds (e.g., Tl₂Se+Tl₃AsSe₃) was heated at successively higher temperatures until melting occurred. The run was maintained above the melting point for up to 8 hours then quenched and the charge examined to determine the stable phase assemblage at the final annealing temperature.

2.1.2 Thermal Analysis Experiments

The experimental system used for obtaining cooling curves consists of a Marshall furnace mounted vertically, a temperature control system, and a LAN AZAR strip chart recorder which produces a direct plot of sample temperature as a function of time (the cooling curve). The recorder is callbrated to record the desired temperature

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interval by means of a L&N K-3 potentiometer. The recorder is normally set to record over a temperature interval of about 100°C. A calibrate-record selector switch permits rapid recalibration to the next desired temperature interval so that data may be recorded over as wide a temperature range as desired. The furnace control system is equipped with a motor drive, so that the cooling rate may be controlled.

Bowever, the temperatures involved in these systems are sufficiently low that satisfactory cooling rates are obtained by simply turning off the heavily insulated furnace and letting it cool at its natural rate.

The quartz sample containers include a thermocouple well which permits the chromel-alumel thermocouple bend to be positioned so that it is surrounded by the sample, but isolated from it. The furnace and sample arrangement is shown in Fig. 1.

A typical run proceeds as follows. The sample tubes are first cleaned by lightly etching with diluted (50-50) hydrofluoric acid. After thorough rinsing, the tubes are baked at 800°C. The inside surfaces of the tubes are then coated with carbon by the pyrolysis of acetone. These preparatory operations are carried out on the sample tubes in order to prevent tube cracking during the melting and freezing reactions which the samples undergo during the thermal cycle. This tube cracking problem did not arise in the case of the selenium compositions, but uncoated tubes used with the sulfur compositions frequently cracked when the charges crystallized. Since the adoption of the carbon coating procedure, however, tube cracking has ceased to be a problem.

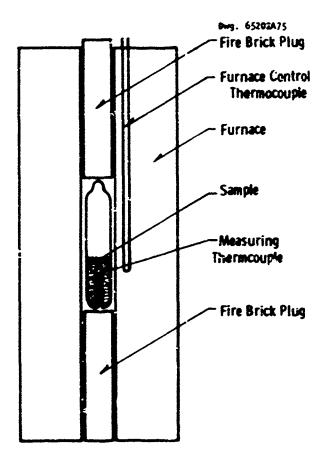


Figure 1 -- Furnace arrangement for thermal analysis.

The required amounts of 99.999 T pure elements (from ASARCO) are weighed and loaded into the sample tubes, which are then evacuated and scaled off. The sample tube is placed horizontally in a cold split furnace and the temperature raised over a period of several hours to 750-800 °C. The sample is shaker several times, and scaked at the high temperature overnight to insure homogenization. The furnace power is then cut and the sample allowed to cool in the furnace.

A chromel-alumed thermocouple is positioned in the therrocouple well, and the leads passed along the sample tube and tied to the ampoule with nichrome wire. The sample is placed in the furnace as shown in Fig. 1, with the thermocouple leads passing through a groove in the upper plug and out the top of the furnace. The thermocouple cold junction is placed in an ice bath.

The sample is then heated to a temperature at least 50°C above the estimated liquidus temperature, then allowed to cool while recording sample temperature as a function of time (the cooling curve).

The sample may be reheated and cooled several times in order to verify the location (temperature) and shape of thermal arrests.

Sample temperature is recorded continuously as a function of time so that heating as well as cooling data are obtained.

2.2 Crystal Growth Techniques

Our experience has shown that the essential features of a crystal-growth technique for congruently-melting sulfosalt materials are: (1) carefully prepared reactant material that precisely matches the congruently-melting composition of the desired crystal, (2) a slow growth rate (10 to 20 mm/day), and (3) a steep (5 to 15°C/mm) temperature gradient at the solid-liquid interface in the crystal growing furnace. Growth facilities were optimized to provide the necessary steep temperature profiles and slow growth rates.

Reactant material for crystal growth is prepared directly from the de-oxidized high-purity elements Tl, As, S, and Se. These

ampoule. Typically, a reactant charge weighs 50 grams. The elemental mixture is heated at a low temperature (200 to 400°C) to react the most volatile component (S or Se) with the metallic elements — a reaction step that is taken to minimize the vapor pressure in the tubes at elevated temperatures. The charge is then he.*: to 700 to 800°C; the liquid is mixed by vigorously shaking the quartz container several times, and the liquid is allowed to crystallize slowly by shutting off power to the furnace. After opening the tube, the crystalline reactant is stored at room temperature in a vacuum desiccator.

For crystal growth, portions of the prepared reactant are sealed under about 0.8 atm pressure of pure argon into quartz "crystal-growing" tubes which contain a necked-in portion near the bottom of the tube. The neck in the tube serves exactly the same purpose as a neck in a Czochralski crystal — to initiate single-crystal growth from a polycrystalline boule. The argon pressure in the tubes suppresses the presence of vapor during a growth run.

Figure 2 shows the quartz-tube furnaces used for crystal growth. Each furnace consists of two heated zones separately controlled by variacs: an upper high-temperature zone and a lower low-temperature zone. The temperature gradient at the solid-liquid interface can be varied by adjusting the voltages to the two windings. As the crystal-growth tubes containing melt drop slowly through the furnace, the melts

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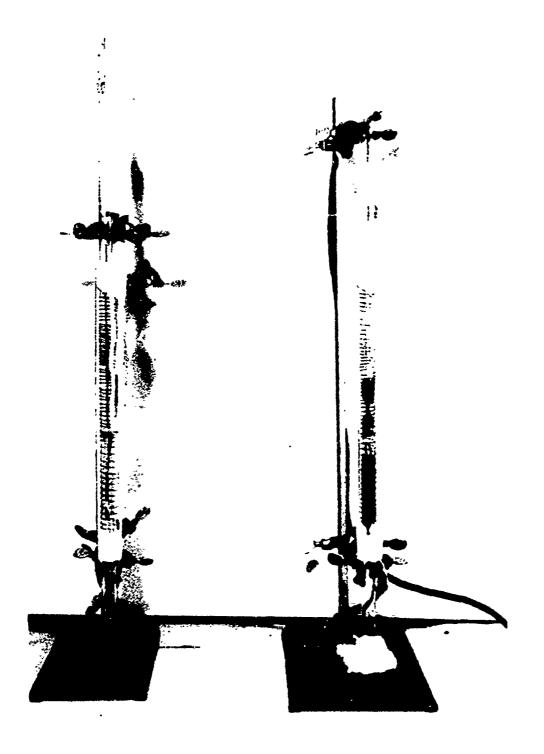


Figure 2 -- Furnaces used for crystal growing.

crystallize when the temperature reaches that of the solidification (melting) point. The grown crystal is allowed to anneal at the temperature of the lower furnace (usually set at about half the melting temperature) and then . >led to room temperature over two to three days.

3. COMPOSITION AND CRYSTAL DATA FOR COMPOUNDS IN THE SYSTEMS T1-As-Se AND T1-As-S

3.1 Composition of Ternary Compounds

The compositions of known compounds in the systems Tl-As-S and Tl-As-Se can best be described in terms of the three-component diagram for each system (Figs. 3 and 4). On each diagram are plotted the compositions of the known binary compounds and the compositions of the ternary compounds known from this study. The following points are germane to this discussion:

- There are several binary T1-S and T1-Se phases 3-5 whose exact compositions and phase relations are not precisely defined. Except for T1₂S and T1₂Se, they do not appear to be involved in the liquidus relations of the important ternary compounds (this point is further discussed in the description of the ternary phase relations). No further data were derived from the present study to clarify the binary phase diagrams.
- The ternary compounds lie on composition joins from Tl₂S to As₂S₃ and As₂S₅, and from Tl₂Se to As₂Se₃ and As₂Se₅. This feature is characteristic of many related systems such as Ag-As-S in which such joins are often pseudobinary.

Three additional ternary phases were studied which are not shown on Figs. 3 and 4. These are the phases ${\rm Tl}_4{\rm As}_2{\rm S}_5$ and ${\rm Tl}_6{\rm As}_4{\rm S}_9$

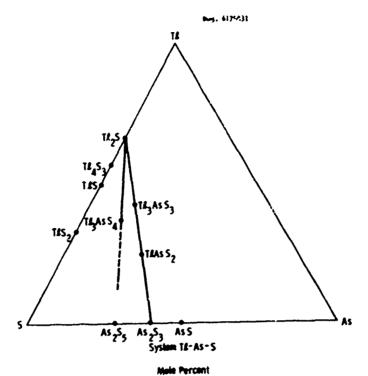


Figure 3 -- Phases in the system T1-As-S.

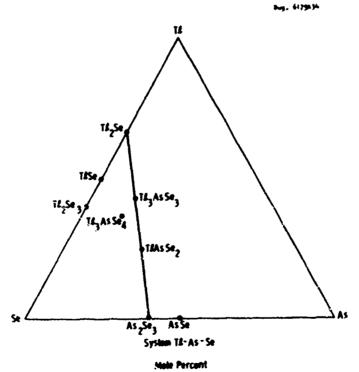


Figure 4 -- Phases in the system T1-As-Se.

previously reported in the literature (and which we could not verify), and a previously unrecognized phase (Phase A) which we believe to be netastable. These phases are discussed in the following section, Crystallographic Data.

3.2 Crystallographic Data

Samples of the ternary compounds have been examined by x-ray powder diffraction methods and small single crystals of Tl₃AsSe₃ and Tl₃AsS₄ have been studied in detail with a Buerger precession camera. The latter technique provides a relatively rapid means of determining crystal symmetry (diffraction aspect) and cell dimensions. The available crystallographic data are described in the following sections.

3.2.1 Tl₃AsSe₃

The single crystal study of this material indicates that it belongs to Laue Class 32/m. The diffraction aspect is $R^{\pm\pm}$ so that the crystal system is hexagonal (rhombohedral). Our observations show that Tl_3AsSe_3 is strongly piezoelectric (indicating an acentric structure), and the space group must be either R32 or R3m. Optical activity was not detected, and crystal class 3m is therefore indicated, i.e., the space group is R3m. The measured cell dimensions are m = 9.90 Å and m = 7.13 Å. is indexed powder diffraction data are reported in Table 1. The measured density is 7.83 grams/cc, which gives a cell content of $Tl_9As_3Se_9$ (D_{calc} . = 7.82 grams/cc).

TlaAsSe, has rhombohedral cleavage.

TABLE 1. X-Rs; Fowder Data for Tl3AsSe3

Indexed for a = 9.80 A, c = 7.08 A							
d _Q bs (A)	I/I _O (estimated)	dcalc (Å)	hk•1				
3.63	0.3	3.64	13.1				
3.25	0.8	3.23	20.2				
2.93	0.2	2.93	33.0				
2.83	0.4	2.80	05.1				
2.72	1.0	2.73	31.2				
2.45	0.1	2.44	25.0				
2.38	0.4	2.38	00.3				
2.36	0.3	2.36	43.1				
1.96	0.1	1.95	61.2				

Pattern limited to $d \ge 1.82 \text{ A}$.

3.2.2 Tl3AsS3

The x-ray powder data for Tl₃AsS₃ show sufficient similarity to those for Tl₃AsSe₃ reported in Table 1 so as to indicate that the two are isostructural. The cell dimensions, although not precisely measured, are slightly less than those for Tl₃AsSe₃, as is to be expected from the relative ionic sizes of 8⁻² and Se⁻². We have not, however, been able to obtain a small perfect crystal for single-crystal investigation; every crystal we have investigated has given streaked and/or sultiple diffraction spots indicating polycrystallinity

or strain. Likewise, Laue photographs of a grown boule indicated very imperfect crystalline quality. We conclude that the two compounds are probably isostructural but the necessary proof from single-crystal x-ray photographs is not available.

3.2.3 Tl3AsS4

Single crystal x-ray studies of Ti_3AsS_4 were undertaken using the Buerger camera. Tl_3AsS_4 is orthornombic with cell dimensions of $\underline{a} = 8.98 \text{ Å}$, $\underline{b} = 10.8 \text{ Å}$, and $\underline{c} = 8.86 \text{ Å}$. The systematic absence of reflections define the diffraction aspect as $\underline{P} = \underline{c} + \underline{n}$ as that the space group is either $\underline{P} = \underline{c} = \underline{n}$ (centric, class $\underline{a} = \underline{a}$) or $\underline{P} = \underline{c} = \underline{n}$ (acentric, class $\underline{a} = \underline{a} = \underline{n}$). In the non-centric space group $\underline{P} = \underline{c} = \underline{n}$, the \underline{b} axis would be the unique or polar axis. Tests for piezoelectricity were negative, and second-harmonic generation at 10.6 μ m was not observed in a single crystal specimen oriented on the phase-matching direction for 10.6 μ m radiation. These negative tests indicate the centric space group $\underline{P} = \underline{c} = \underline{n}$. The measured density is 6.20 \pm 0.04 grams/cm³, which gives a cell content of $4(\text{Tl}_3\text{AsS}_4)$.

3.2.4 Tl₃AsSe₄

X-ray powder diffraction data indicate that Tl₃AsSe₄ is isostructural with Tl₃AsS₄, i.e., this compound has a centric orthorhomic crystal structure. Unfortunately, large single crystals of this material were obtained late in the program, and no single-crystal x-ray precession photographs were taken. Study of this material will be continued during the coming year.

3.2.5 TlAsS₂ and TlAsSe₂

The compound TlAsS₂ is well known as the monoclinic mineral lorandite⁶. Its space group is either P?/x or $P2_1/x$ and the cell prameters are a = 12.25, b = 11.32, c = 6.10 Å, $\beta = 104^{\circ}$ 12. The compound TlAsSe₂ is not known naturally; the x-ray powder data are quite similar to those of TlAsS₂ so that there is little doubt that this compound too is one of low symmetry. Several crystal growth attempts for TlAsS₂ and TlAsSe₂ (see Sec. 5.3.5 and 5.3.6) were not successful, and no further attention was devoted to their crystallography since their low symmetry would make them doubtful candidates for useful optical applications.

3.2.6 Phase A (unknown T1-As-S Phase)

A previously unknown T1-As-S phase was obtained in melts of composition T1₃AsS₃ + 1 mol % As₂S₃ crystallized by slowly cooling the charge to room temperature. These melts crystallized to a mass of crystals showing bladed habit. Small crystals were separated for microscope examination — they are birefringent in both transmitted and reflected light and transmit in the red portion of the visible spectrum. They have parallel extinction and at least two excellent cleavages — one parallel and one normal the length of the crystals. The x-ray pattern is complex and quite unlike the patterns of the other phases in the system. Our observations concerning the composition and stability of this phase (Phase A) are summarized below:

- Phase A has only been identified in runs containing 26 mol %

 As₂S₃ (Tl₃AsS₃ + 1 mol % As₂S₃). Runs containing 30 and 33.3 mol %

 (Tl₃AsS₃ + 5 and 8.3 mol %) showed Tl₃AsS₃ as the primary phase to crystallize.
- 2) We have never obtained pure Phase A always there is some second phase present.
- 3) Phase A was never obtained at Tl₃AsS₃ composition, either when Tl₃AsS₃ melts are slowly cooled or when such melts were rapidly chilled in ice water.
- 4) A crystal growth run prepared with a reactant containing

 26 mol % As₂S₃ resulted in a polycrystalline boule of Tl₃AsS₃.
- 5) Phase A appears to be unstable at room temperature because we observed a distinct breakdown texture (Fig. 5) forming in samples

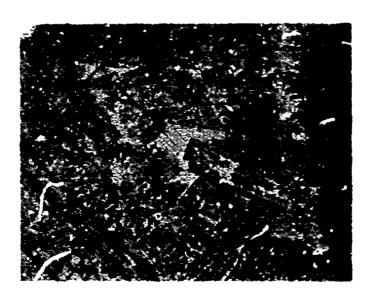


Fig. 5 -- Brenkdown texture (X100) in previouslyhomogeneous Phase A after storing at room temperature for 5 weeks.

kept at room temperature for a few weeks. X-ray powder patterns are different than for the original material but still complex.

- 6) Portions of previously-synthesized Phase A heated at 240°C, 275°C, and 298°C quickly (4 hours) decomposed to Tl₃AsS₃.
- 7) There was no evidence for the existence of such a compound in any of our thermal analysis experiments.

We believe that our observations on Phase A are consistent with a hypothesis that this compound is a metastable phase which forms only within. Any restricted temperature and compositional range; its occurrence probably also depends on the preparation technique. Metastable phases of this type are relatively common in sulfide systems, e.g. in the system Cu-Sb-S.

We separated several small (sub-millimeter) crystals to determine the crystal symmetry by single-crystal x-ray studies. All the fragments examined, however, showed severe distortion and cracking, probably caused by the unstable nature of Phase A at room temperature.

3.2.7 T.,482S5 and T16As4S9

Attempts were made to synthesize the compounds ${\rm Tl}_4{\rm As}_2{\rm S}_5$ and ${\rm Tl}_6{\rm As}_4{\rm S}_9$ reported by Canneri and Fernandes⁸. For ${\rm Tl}_4{\rm As}_2{\rm S}_5$, a melt of ${\rm Tl}_4{\rm As}_2{\rm S}_5$ composition was prepared by heating the required mixture of elements at 700°C for about 16 hours. The charge was cocled to room temperature and examined by x-ray and microscope polished section — the charge was polyphase, with ${\rm Tl}_3{\rm AsS}_3$ being the primary phase to

crystallize as demonstrated by its dendritic habit. Portions of this charge were heated at successively higher temperatures until melting occurred. Initial melting was observed in two separate runs at 228-232° and 228-233° which corresponds to the 231 + 3°C temperature we find for the eutectic temperature between TlAsS₂ and Tl₃AsS₃ (See Sec. 4.2.3). Similar results were obtained for Tl₆As₄S₉, whose reported composition is very nearly that of the Tl₃AsS₃-TlAsS₂ eutectic composition.

4. PHASE RELATIONS IN THE SYSTEMS T1-As-Se AND T1-As-S

4.) Data in the Literature

A pseudobinary phase diagram for the system ${\rm Tl}_2{\rm Se-As}_2{\rm Se}_3$ was reported by Dembovskii, Kirilenko, and Khvorostenko⁹. Their diagram, reproduced in Fig. 6, shows only two intermediate compounds,

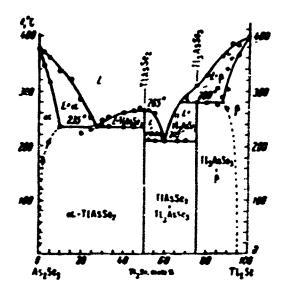


Fig. 6 -- Equilibrium diagram of the As₂Se₃-Tl₂Se system, according to Denbovskii et al.⁹

Tl₃AsSe₃ and TlAsSe₂, between the two components. Their diagram is quite similar to the diagram we report below in Sec. 4.2 except for one notable discrepancy — the compound Tl₃AsSe₃ is shown to melt

incongruently at 280°C whereas we find congruent melting at 311°C. The diagrams are compared and the discrepancies discussed in the next section.

A previous diagram for the system Tl₂S-As₂S₃ reported by Canneri and Fernandes⁸ bears little resemblance to that reported here. According to their diagram (Fig. 7), there are four pseudobinary phases: Tl₃AsS₃, Tl₄As₂S₅ (mistakenly shown as Tl₄As₂S₃), Tl₅As₄S₉, and TlAsS₂. Of these, we find only Tl₃AsS₃ and TlAsS₂ to be stable

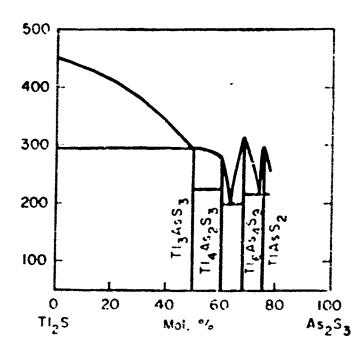


Fig. 7 -- System Tl₂S-As₂S₃ according to Carneri and Fernandes.⁸

phases in this system (see Sec. 3.2.7). The phase diagram by Canneri and Fernandes is based solely on thermal arrest experiments;

we find that thermal data are notably unreliable in the As₂S₃-rich portion of the Tl₂S-As₂S₃ system because of supercooling and netastability phenomenon. Such problems, as well as the impure reactant materials used by Canneri and Fernandes, probably account for the errors in their diagram.

4.2 Phase Relations Determined in this Study

4.2.1 Introduction

As noted in Sec. 3.1, the important ternary compound in the systems Tl-As-Se and Tl-As-S lie on composition joins such as Tl₂Se-As₂Se₃ and Tl₂S-As₂S₃. The approach used in the phase diagram study was to determine the melting relations along these joins using both quench-type and thermal analysis experiments. In most cases the joins are pseudobinary, or nearly so, so that they can be treated as two-component systems, remembering, however, that phases such as the vapor phase (always present in a rigid container) have compositions that lie off the joins.

4.2.2 The Join Tl₂Se-As₂Se₃

This join (Fig. 8) is perhaps the most important join in the Tl-As-S-Se system from a device standpoint because it contains the nonlinear compound Tl₃AsSe₃. There are two pseudobinary compounds, Tl₃AsSe₃ and TlAsSe₂, with intermediate pseudobinary sutectics. Both phases have narrow solubility limits, probably less than 1 mole I

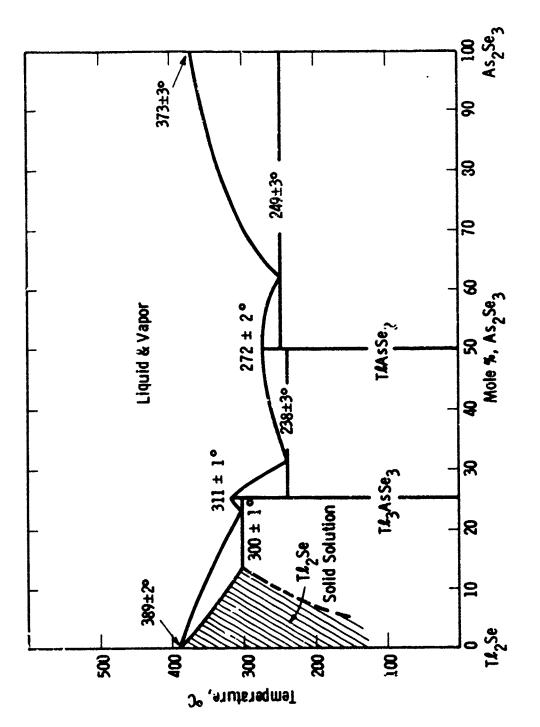


Fig. 8 -- Phase relations along the jo'n Il₂Se-As₂Se₃ according to this study.

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toward Tl₂Se or As₂Se₃, as demonstrated both by appearance of phase experiments and by the very small shifts in x-ray line positions on powder photographs. There is, however, a surprisingly large solid solution of Tl₂Se toward As₂Se₃: 10 mole % or more at 300°C; the solid solution limits were not precisely defined / ace they are of little importance to our crystal growth efforts.

Substantial effort was applied to determining the exact melting relations of Tl₃AsSe₃ because these relations are crucial to TlaAsSe, crystal growth. An expanded phase diagram for a portion of the Tl₂Se-As₂Se₄ system is shown in Fig. 9. The maximum melting composition does not lie at the stoichiometric Tl3AsSe3 composition, but at a point slightly toward ${\rm Tl}_2{\rm Se}$ from ideal, at 24.625 mole X As Seq. The freezing temperatures obtained from the cooling curves alone were not sufficient to locate the maximum melting composition this accurately. The presence or absence of the eutectic arrests at 300°C and 240°C permitted the maximum to be defined more precisely than the freezing temperatures taken alone. A 24.75 mole % As Se composition showed only the lower eutectic, indicating that this composition lies to the ${\rm As}_2{\rm Se}_3$ -rich side of the maximum. A 24.5 mole X As 2Se 2 composition showed only the upper eutectic, indicating that this composition lies to the ${
m Tl}_2{
m Se-rich}$ side of the maximum. A 24.625 mole % As_2Se_3 sample showed faint arrests corresponding to both eutectics. Of course, the maximum welting composition should ideally show neither eutectic; however, slight compositional inhomogeneities

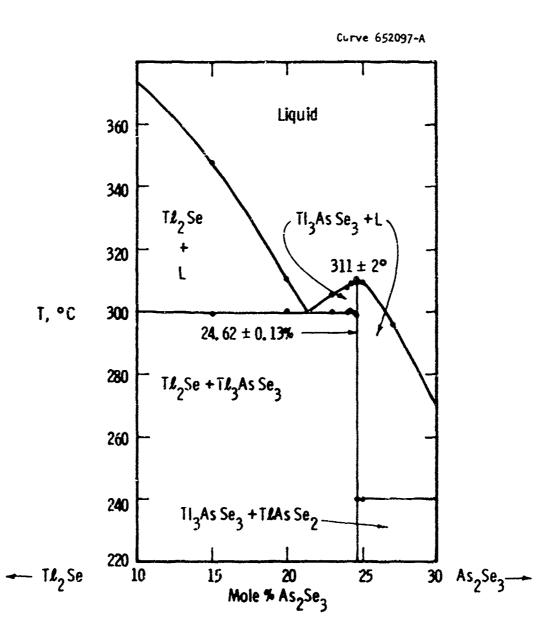


Fig. 9 --- Partial phase diagram for the Tl₂Se-As₂Se₃ system. The points represent thermal arrests.

in the melt probably account for the appearance of both eutectics. The implications of Fig. 9 for the crystal growth of ${\rm Tl}_3{\rm AsSe}_3$ will be discussed in detail in Sec. 5.3.1; it is sufficient to note here, however, that there is a substantial improvement in crystals grown from melts containing 24.625 mol % ${\rm As}_2{\rm S}_3$ over those grown from a stoichiometric ${\rm Tl}_3{\rm AsSe}_3$ melt.

A comparison of Fig. 8 with Fig. 6 shows that our results agree with those of Demborskii et al. 9 in that the eutectic temperatures and the TlAsSe₂ melting temperature are in fair agreement for the two studies. The major discrepancy deals with the melting relations of Tl₃AsSe₃; according to Dembovskii et al. Tl₃AsSe₃ melts incongruently at 280°C to a mixture of Tl₂Se (β) and liquid. Our experiments show that Tl₃AsSe₃ melts congruently at 311°C. Several lines of evidence in addition to our thermal data indicate this to be correct:

- We cannot detect any melting when small portions of Tl₃AsSe₃ are heated in sealed tubes below 311°C. According to the Dembovskii et al. phase diagram, the equilibrium assemblage should be Tl₂Se + L between 280°C and ~ 316°C. The presence of liquid should be clearly visible in our experiments.
- 2) Rapidly-quenched charges of Tl₃A₂Se₃ liquid appear to be homogeneous Tl₃A₅Se₃ in polished section under the microscope. It is unlikely that that equilibrium would be maintained in such chilled samples so that incongruent melting would be indicated by polyphase products.

3) Slowly-cooled melts such as we use for crystal growth would initially crystallize to Tl₂Se according to the Dembovskii et al. diagram. We see no evidence of this in our crystal growth runs. Large single crystals of Tl₃AsSe₃ would be an unlikely product if, in fact, the compound melted incongruently.

We thus feel that all the evidence supports our contention that ${\rm Tl}_3{\rm AsSe}_3$ melts congruently rather than incongruently; we cannot, however, offer any explanation for the discrepancy.

Long-term annealing experiments conducted to determine whether there are other intermediate phases, besides Tl₃AsSe₃ and TlAsSe₂, are summarized in Table 2. To aid the attainment of equilibrium, reactant material was either melted prior to use, or consisted of previously-synthesized compounds which were pressed into pellets to ensure intimate contact between the reactant phases. The only product phases identified by x-ray powder diffraction were Tl₂Se, Tl₃AsSe₃, TlAsSe₂, or As₂Se₃. We conclude that there are no intermediate phases in the system Tl₂Se-As₂Se₃ at temperatures of 150°C or above.

4.2.3 The Tl₂S-As₂S₃ Join

The partial phase diagram for the ${\rm Tl}_2{\rm S-As}_2{\rm Se}_3$ system is shown in Fig. 10. The eutectic horizontal at 231°C was obtained from heating curves and quenching. Cooling curve arrests corresponding to this eutectic were as much as 45°C low. No liquidus arrests were obtained for compositions containing 35 mol ℓ or more ${\rm As}_2{\rm S}_3$, due to

TABLE 2

Low-Temperature Annealing Experiments

Run No.	Reactant Key	T, °C	Time	Products
TAS 73	1	200°C	11 days	Tl ₂ Se + Tl ₃ AsSe ₃
TAS 88	2	200°C	36 days	Tl ₃ AsSe ₃ + TlAsSe ₂
TAS 89	3	200°C	36 days	$TlAsSe_2 + As_2Se_3$
TAS 80	1	150°C	61 days	Tl ₂ Se + Tl ₃ AsSe ₃
TAS 81	4	150°C	61 days	T13AsSe3 + T1AsSe2
TAS 83	5	150°C	61 days	TlAsSe ₂ + As ₂ Se ₃

- 1) Composition 15 mol % As 2 Se 3; melted prior to annealing.
- 2) Pressed pellet of Tl₃AsSe₃ + TlAsSe₂.
- 3) Pressed pellet of $TlAsSe_2 + As_2Se_3$.
- 4) Composition 35 mol % As₂Se₃; melted prior to annealing.
- 5) Composition 70 mol 4 As $_2$ Se $_3$; melted prior to annealing.

the formation of glasses on cooling. We did, however, do melting-point experiments on TlAsS $_2$ and find that it melts congruently at 286 \pm 3°C.

Compositions lying on the ${\rm Tl}_2{\rm S-As}_2{\rm S}_3$ join yielded reliable data with great reluctance. The compositions tested lying on the ${\rm Tl}_2{\rm S}$ rich side of the eutectic at about 22% ${\rm As}_2{\rm S}_3$ did not define the liquidus in this region. When run in normal fashion, i.e., cooling the melt from 50°C or more above the estimated liquidus, compositions on the ${\rm As}_2{\rm S}_3$ -rich side of the mat num yielded arrests corresponding to

the dotted curve. These compositions exhibited substantial supercooling (30°C or more). We also observed that the temperature rise following nucleation was sluggish. This system is clearly not "well-behaved" in a classical sense, so that the data obtained to this point raised more questions than they answered.

We hypothesized that there was some partial structure remaining in the liquid at temperatures slightly above the liquidus, which is broken up at the higher temperatures to which the melt is generally heated. On subsequent cooling from a high temperature, nucleation and growth occur with difficulty. We then reran several samples in an attempt to hold the maximum temperature of the melt within about 10°C of the liquidus arrest. The desired temperature was estimated from the heating curve, which indicated liquidus temperatures considerably higher than those obtained from the previous cooling curves. After some trial and error, we were able to obtain cooling curves with no supercooling. In fact, when the maximum melt temperature did not exceed 10°C above the liquidus, the arrests formed a smooth curve without the sharp break associated with sudden nucleation. These experiments yielded the solid curve on the As₂S₃-rich side of the maximum.

4.2.4 The $Tl_2S-As_2S_5$ Join

The composition join ${\rm Tl}_2{\rm S-As}_2{\rm S}_2$ appears pseudobinary, at liquidus temperatures, over the range 0 to 35 mol % ${\rm As}_2{\rm S}_5$. The diagram is shown in Fig. 11. The group of points in the neighborhood of

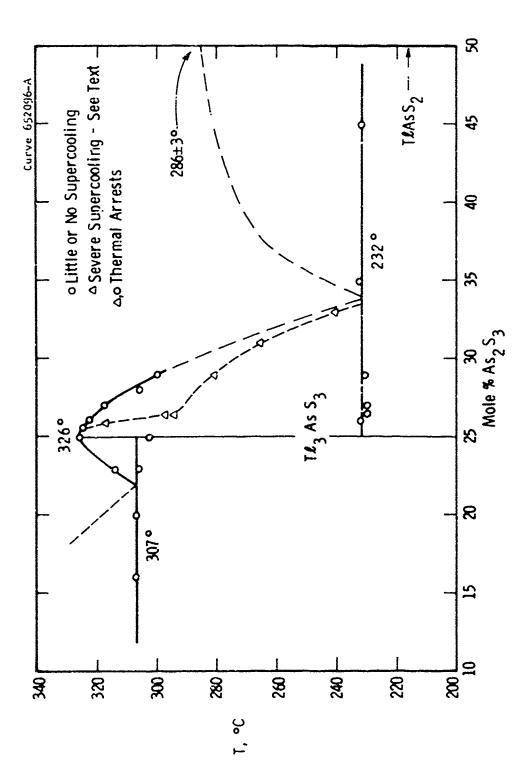
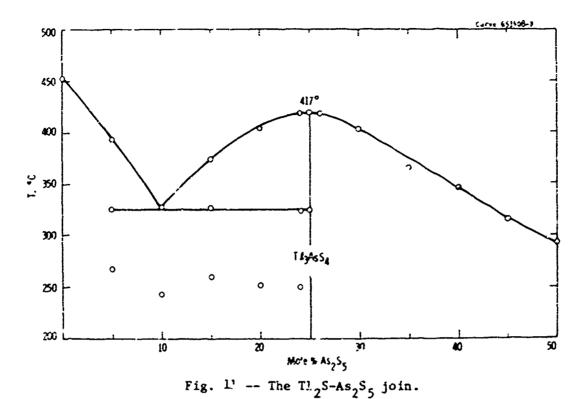


Fig. 10 -- Partial phase diagram for the system ${\rm Tl}_2{\rm S}{\cdot\cdot\Lambda s}_2{\rm S}_3$.



250°C on the Tl₂S-rich side of Tl₃AsS₄ corresponds to very small thermal arrests observed on cooling curves for all the compositions examined on that portion of the join. These points probably correspond to a single temperature, as it is not uncommon to observe some scatter in the temperature at which very small arrests occur in systems where the phases involved exhibit substantial supercooling. They probably represent the temperature of a ternary eutectic lying off the composition join, but their origin was not pursued. The maximum-melting Tl₃AsS₄ composition appears to lie at 25 mol % As₂S₅, i.e., at least as viewed on this join, the compound is stoichiometric.

The Tl₃AsS₄ liquidus surface on this join was studied to a composition 50 mol % As₂S₅; the curve descends smoothly and there is no indication of additional congruently-melting compounds intersecting the liquidus surface.

4.2.5 Tl₃AsS₃-S Join

The composition join Tl_3AsS_3-S was studied, not only to define the melting relations of Tl_3AsS_3 , but also those of Tl_3AsS_4 . The phase diagram is shown in Fig. 12.

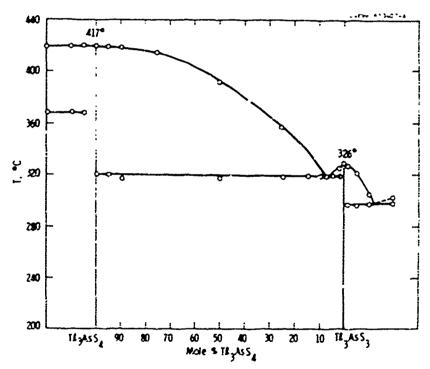


Fig. 12 -- A portion of the Tl3AsS3-S join. The points represent arrests in thermal analysis experiments.

An eutectic between ${\rm Tl}_3{\rm AsS}_3$ and ${\rm Tl}_3{\rm AsS}_4$ occurs at 320°C and at a composition very near ${\rm Tl}_3{\rm AsS}_3$. The close proximity of the

two eutectics to ${\rm Tl}_3{\rm AsS}_3$ can be appreciated by noting that the difference in sulfur content between ${\rm Tl}_3{\rm AsS}_3$ and ${\rm Tl}_3{\rm AsS}_4$ is only about 3.4 wt %.

The liquidus surface for ${\rm Tl}_3{\rm AsS}_4$ is very broad, as it was also on the ${\rm Tl}_2{\rm S-As}_2{\rm S}_5$ join. Repeated examination of the thermal data produced by stoichiometric ${\rm Tl}_3{\rm AsS}_4$ show a small heating arrest at about 320°C, indicating that the true maximum-melting composition lies slightly off the stoichiometric composition, probably toward sulfur. This observation is discussed further with reference to the crystal growth of ${\rm Tl}_3{\rm AsS}_4$.

4.2.6 $Tl_2Se-As_2Se_5$ and $Tl_3AsSe_3-Tl_3AsSe_4$ Joins

The thermal analysis data did not yield clear results for the phase boundaries in the region of Tl₃AsSe₄. If there is indeed a maximum in the liquidus, it is very cmall, with an eutectic within one or two percent of the stoichiometric composition on the Tl₂Se side. Our data do not rule out a peritectic reaction, but if such is the case, the intersection of the peritectic horizontal with the liquidus must occur very near the equilibrium compound composition, based not only on the thermal data but also on our success in preparing good crystalline material with our normal crystal growth techniques.

The liquidus is rather broad from Tl₃AsSe₃ toward Tl₃AsSe₄. However, for compositions richer in sulfur than Tl₃AsSe_{3.85}, the data again cannot be interpreted.

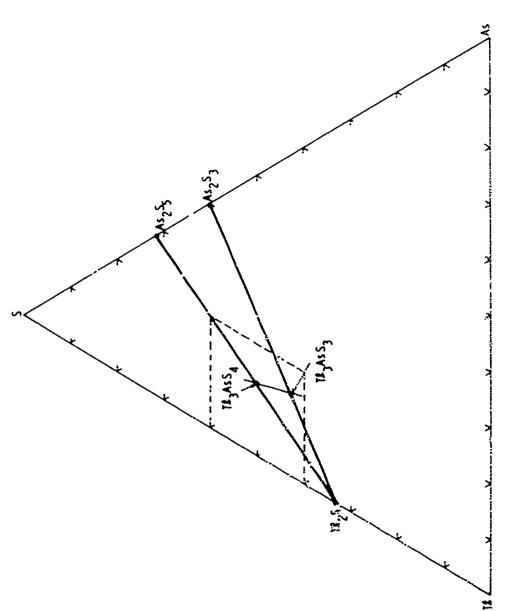
Thus, even though the exact phase relationships in the immediate vicinity of Tl₃AsSe₄ are not well defined, the region of uncertainty occupies a very small composition region in the ternary system, and thus the region of exploration for crystal growth experiments is fairly well defined.

4.2.7 Ternary Phase Relations

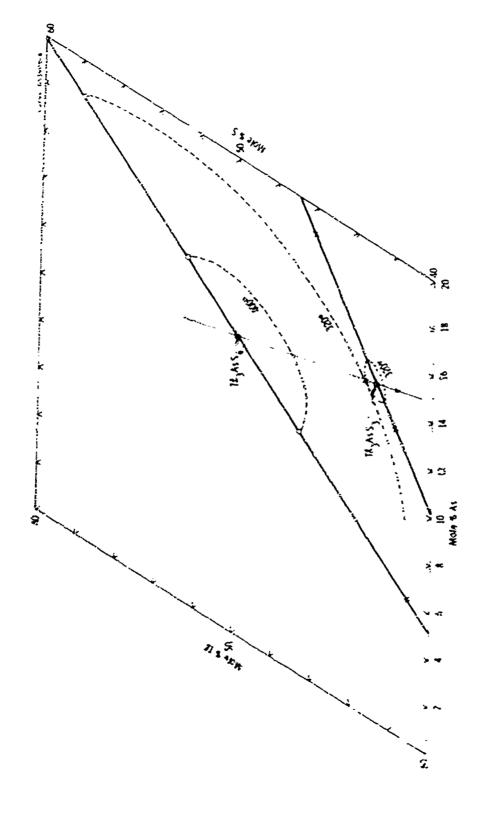
The results of the phase diagram work on the Tl₂S-As₂S₃, Tl₂S-As₂S₅ and Tl₃AsS₃-Tl₃AsS₄ joins are brought together in Figs. 13 and 14. Figure 13 is an overview of the Tl-As-S ternary system which defines the three joins in terms of the elemental components and shows their mutual relationships. Figure 14 is a detailed view of the region of the ternary shown in Fig. 13 which cor. aims Tl₃AsS₃ and Tl₃AsS₄. The eutectics observed on the various joins are marked X in Fig. 14. Isotherms at 320°C and 400°C are shown as dashed curves. The 320°C isotherms intersect the eutectic closest to Tl₃AsS₃ on the Tl₃AsS₄ join.

rigure 14 clearly illustrates the narrowness of the Tl₃asS₃ maximum and the broadness of the Tl₃AsS₄ maximum in relation to nearby eutectics. These ternary relationships have a strong bearing on the growth of high quality single crystals, particularly of Tl₃AsS₃. The phase diagram data indicate that the maximum melting composition for Tl₃AsS₃ is very close to stoichiometry. However, the close proximity of the eutectics surrounding Tl₃AsS₃ will require the maximum melting composition to be known to an extreme degree of precision if high quality crystals are to be grown.

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Pig. 13 -- The Il-As-S Ternary System. The outlined portion is shown enlarged in Fig. 14.



"ig. 14 --- Detail of TI-An-S syntem in the region of Tl₃AnS₃ and Tl₃AnS₄;
the N¹B correspond to eutectics on the pseudobinary joins

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5. CRYSTAL GROWTH

5.1 Introduction

The available data on phase relations have important implications for crystal growth of sulfosalt compounds. We have been able to grow high quality crystals of Tl₃As5e₃ and Tl₃As5e₄, but only fair quality crystals of Tl₃As6₃ and Tl₃As6e₄. We believe the phase diagram study explains this observation. Our study revealed that these latter two compounds are surrounded by pseudobinary eutectics that are close in composition to the congruently melting compositions. Thus, crystal growth may well be hampered by "eutectic interference" of the type proposed to explain growth phenomena in proustite, Ag₃As6₃. In the case of the compounds Tl₃As6e₃ and Tl₃As6₄, although pseudobinary eutectics are present, they live at more distant compositions from the stoichiometric compounds and thus eutectic interference does not impede the growth of large crystals. Our methods of crystal-quality evaluation and crystal growth efforts for each compound studied are described below.

5.2 Crystal-Quality Evaluation

Of the crystals examined during this study, only ${
m Tl}_3{
m AsS}_4$ was transparent in a portion of the visible wavelength spectrum. Thus,

the crystal quality of Ti₃AsS₄ could be quickly determined by visual inspection (i.e., were cracks present?) and by illuminating the interior of the crystal with a He-Ne laser beam. This latter technique was particularly useful for detecting tiny light-scattering inclusions.

The band-edges of Tl₃AsS₃, Tl₃AsSe₃, and Tl₃AsSe₄ were in the near infrared and it was therefore impossible to inspect or measure the optical quality of bulk single crystals using visible radiation. Initially, we attempted to use an infrared image converter camera (Bofars MARK IRCD-1) with suitable infrared optics, to image crystal interiors at a wavelength of about 1.5 µm. The resolution of this system was unsatisfactory, although with further work on the optics we believe it could be improved considerably.

A scanning technique for profiling the optical loss in single sulfosait crystals has been set up, as shown in Fig. 15. An infrared laser beam is incident onto a Tl₃AsSe₃ boule onto which plane parallel inspection faces have been ground and rolished. The power transmitted through the crystal is recorded as the various portions of the crystal are translated through the beam, and the rotal optical loss is thus characterized as a function of crystal position. It should be noted that this measurement technique gives only the total loss through the crystal. To account accurately for reflection losses, the crystal refractive indices and its orientation relative to the polarization of the incident beam must be known. In addition, low angle scattering losses are not accounted for, because the power meter acceptance solid angle is relatively large, about 2 x 10⁻³ steradians.

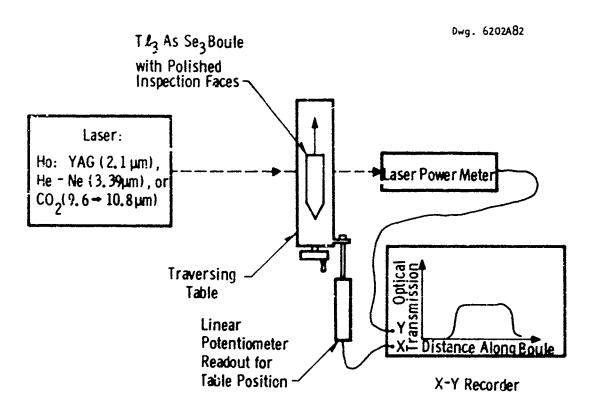


Fig. 15 -- Schematic diagram of optical quality scanning system for sulfosalt crystals.

In Fig. 16 is shown the result of a scan of a 4 cm long Tl_3AsSe_3 crystal, TASE-BR-1, at 2.1 μm (Ho:YAG laser). In this case, the seed end is of reasonably good quality, with total optical transmission within 5-10% of the maximum expected when reflection losses are taken into account. Total internal reflection at a cracked section about 2.5 cm from the tail end reduces the transmission to zero in that region; a very lossy region also extends from about 0.5 cm t. 2 cm along the boule. Scans of this type were also used to evaluate the optical quality of Tl_3AsS_3 and Tl_3AsSe_4 .

5.3 Crystal Growth

5.3.1 Tl₃AsSe₃

Crystals of ${\rm Tl}_3{\rm AsSe}_3$ were grown at three compositions to determine the optimum growth composition: 1) stoichiometric ${\rm Tl}_3{\rm AsSe}_3$, which contains 25 mol % ${\rm As}_2{\rm Se}_3$; 2) a composition $({\rm Tl}_2{\rm Se})_{0.75375}$. (As $_2{\rm Se}_3$) $_{0.24625}$, and 3) a composition $({\rm Tl}_2{\rm Se})_{0.7525}$ (As $_2{\rm Se}_3$) $_{0.2475}$. The latter two compositions lie on the ${\rm Fl}_2{\rm Se-As}_2{\rm Se}_3$ composition join but slightly more ${\rm Tl}_2{\rm Se-rich}$ than stoichiometric ${\rm Tl}_3{\rm AsSe}_3$; composition 2) corresponds to the maximum-melting composition as determined by the phase-diagram study. Eight crystal-growth experiments are described in Table 3.

The crystals we grew were examined using our scanning technique. With the total optical losses approaching only a few percent, it is very difficult to obtain accurate measurements of losses and to compare effects of stoichiometry and growth rate on crystal quality

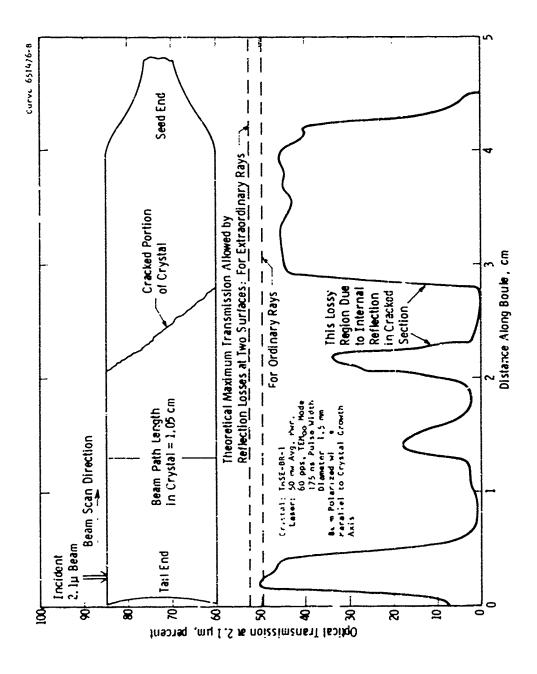


Fig. 15 -- Optical transmission at 2.1 μm along an as-grown boule of TljAsSe $_3$

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using this transmission technique. This is, however, a useful method for finding the best sections in a particular boule.

In general, the results of Table 3 indicate that x=0.75375 to x=0.7525 and a growth rate of the order of 15 mm/day are optimum growth conditions for high quality Tl_3AsSe_3 . This is dramatically illustrated by a comparison of crystals TASE-BR-3 and TASE-BR-6 (Figs. 17 and 18). Crystal TASE-BR-3 was grown from the maximum-melting composition; it exhibits large clear regions with bulk losses of nearly zero, at least within the accuracy of our

TABLE 3
Optical Loss Measurements on Tl₃AsSe₃ Boules

Boule No.	Composition (Tl ₂ Se) _x (As ₂ Se ₃) _{1-x}	Growth Rate (mm/day)	Length of Best Section (cm)	Optical Loss in Best Section (cm ⁻¹)
BR-1	(0.75375)(0.24625)	12.2	1.2	0.05 + 0.08
BR-2	(0.75250)(0.24750)	10.5	0.8	0.05 -> 0.08
BR-3	(0.75375)(0.24625)	15.3	1.6	∿ 0
BR-4	(0.75250)(0.24750)	15.0	1.0	0.02 + 0.04
BR-5	(C.75375)(O.24625)	15.8	2.2	0.03 + 0.06
BR-6	(0.75000)(0.25000)	15.0	2.2	0.03 - 0.06
BR-8	(0.75375)(0.24625)	15.4	1.2	0.02 + 0.04

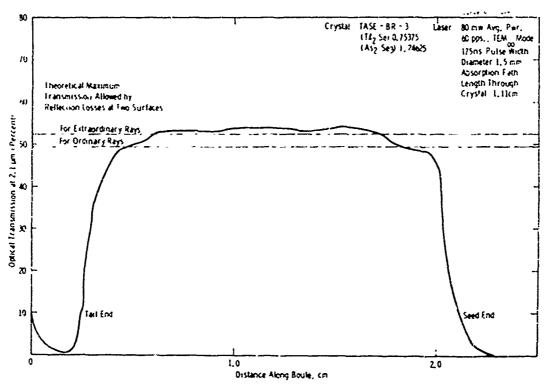


Fig. 17 -- Optical transmission at 2.1 µm along an as-grown boule of Tl₃AsSe₃, Crystal TASE-BR-3.

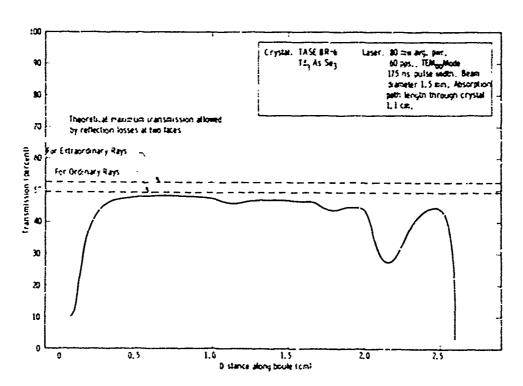


Fig. 18 -- Optical transmission at 2.1 µm along an as-grown boule of Tl3AsSe3 (Crystal TASE-BR-6).

me Lurement technique. The transmission of BR-3 actually appears to exceed the theoretical maximum by a small amount; this is probably due to a slow fluctuation in the probe laser average power, which is continually monitored but fluctuates by about $\pm 2\%$. The actual losses in BP-3 appear to be approaching 0.01 cm⁻¹ or less.

Crystals grown from stoichiometric Tl₃AsSe₃ melts (e.g., T/.SE-BR-6), on the other hand, have optical transmissions that do not attain theoretical maximum values (Fig. 18). Often such crystals have variable transmission along the length of the crystal and are also prone to have high-absorption bands, probably impurity bands. The differences are striking considering that only a few tenths of a mol % change in melt composition is involved.

5.3.2 Tl3AsS4

The ternary melting relations determined for Tl₃AsS₄ (see F g. 14) show that there is a very broad liquidus surface surrounding the stoichiometric composition. Insofar as we can tell, the melting maximum on the join Tl₂S-As₂S₅ occurs at the stoichiometric Tl₃AsS₄ composition; because of the rather flat melting maximum on the join Tl₃AsS₃-S, however, there is uncertainty in the exact maximum-melting composition. For this reason, we conducted a eries of crystal growth experiments along the join Tl₃AsS₃-S to determine the optimum Tl₃AsS₄ growth composition empirically, i.e., by growing crystals from melts containing different amounts of S and comparing the crystals as to their optical quality.

Crystals were grown from four compositions: Tl₃AsS_{3.95}, Tl₃AsS₄, fl₃AsS_{4.01} and Tl₃AsS_{4.025} (the experimental details are contained in Tal. 4). Two problems are evident -- crystal cracking and inclusions (best observed as light-scattering centers when crystals are illuminated with a He-Ne laser beam). In fact, however, these two problems are not independent — crystals with a high inclusion content showed a strong proclivity to fracture on cooling.

The composition Tl₃AsS_{3.95} was chosen to evaluate crystal growth from melts s_ightly sulfur. I ficient from the ideal composition. Three separate growth runs were made to ensure reasonable statistics for the data and eliminate possible spurious results caused, for example, by accidentally misweighing reactants. The results clearly show that Tl₃AsS_{3.95} is not a preferred growth composition. Crystals were always severely cracked and, in two of the three runs, single-crystal growth broke down and polycrystalline material comprised several millimeters of the boule length at the end of the charge. In addition, there was a metallic-appearing coating on portions of the surface of the charge (and in all probability it was similar particles that occurred as scattering centers inside the boule). We tried to remove enough of the coating to obtain a powder-diffraction pattern but were not successful.

Similar problems to those described for ${\rm Tl}_3{\rm AsS}_{3.95}$ were evident in growth runs on melts of ${\rm Tl}_3{\rm AsS}_4$ composition but to a lesser extent. We were, in fact, able to obtain an uncracked soule at room

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Crystal-Growth Experiments Conducted to Determine Optimum Growth Composition for Tl₃As54

Run Number	Maît Composition	Growth Rate mm/day	Results
203806-84	Tl3AgS3.95	1.5	Cracked, top of charge polycrystalline
203806-140	T13AsS3.95	15	Cracked, top of charge polycrystalline
203806-143	T13A8S3.95	7:	boule completely cracked
204849-34	Tl 3A8S4	15	Boule badly cracked
204849-44	Tl 3AnS4	15.5	Boule badly cracked
294849-98-1	T13A8S4	11.5	Boule cracked
294849-98-2*	71 3 A & S 4	ω	Uncracked boule obtained at room temperature; boule later cracked spontaneously. Contain: inclusions.
206196-3	Tl ₃ Ass _{4.01}	18	2 cm of uncracked material (entire boule) inclusion confent low.
206196-1	T13A8S4.025	15.5	1.5 cm of uncracked material; inclusion content low; excess sulfur present

* A rerun of Boule 204849-98-1.

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temperature (although it spontaneously cracked after a few weeks at room temperature) by regrowing a crystal at a slow growth rate (8 mm/day). This procedure in effect uses the first furnace pass as a zone refining step for subsequent crystal growth. Still, however, the crystal contained memerous inclusions. There is a marked diminishing of the metallic surface coating on going from melts of Tl₃AsS_{3.95} to melts of Tl₃AsS₄ composition, which indicated that we were changing composition in the right direction, i.e., that the maximum-melting composition for this phase contains slightly more sulfur than indicated by the formula Tl₃AsS₄. Our observation of a thermal arrest at the Tl₃AsS₄-Tl₃AsS₃ eutectic temperature (320°C) in a melt of composition Tl₃AsS₄ supported this conclusion.

Uncracked crystal lengths exceeding 1 cm were obtained for crystals grown with sulfur in excess of the ideal S₄ composition, and in fact the boule was crack-free for Tl₃AsS_{4.01}. Excess sulfur was present in the crystal-growth run from Tl₃AsS_{4.025} composition; it coated the tube as a surfur-rich liquid during growth. These observations clearly substantiate our phase diagram interpretation that the maximum-melting Tl₃AsS₄ composition lies slightly toward sulfur from the ideal formula.

5.3.3 Tl₃AsS₃

The phase diagrams show that the growth composition is critical for Tl3AsS3 growth. This compound is surrounded on all

melting point will quickly result in the melt reaching an eutectic composition at the growing interface. Although we do not yet know the optimum composition for growing ${
m Tl}_3{
m AsS}_3$, the techniques have been improved to an extent so that single crystal sizes are now available to allow the measurement of the material properties.

Boules grown from stoichiometric Tl₃AsS₃ melts are invariably polycrystalline. Results of a scan at 2.1 µm of a longitudinal slice from a recent boule indicate extremely high losses (~ 10 cm⁻¹) near the seed end, but considerably lower losses (~ 1.5 to 2 cm⁻¹) in a region near the tail end of the crystal. These losses are too high for practical applications. The surface of this crystal contained numerous bubbles that we interpreted as indicating the presence of excess sulfur during crystal growth. Therefore, the sulfur content was reduced and an attempt made to grow from a Tl₃AsS_{2.995} composition melt.

The boule contained from the sulfur-deficient melt had sections of much higher optical quality than any obtained before. A section of single crystal 0.4 cm in length and 1 cm in diameter was obtained with losses on the order of 0.1 to 0.5 cm⁻¹. Clearly, this optical quality is not sufficient for device use; we were, however, able to measure the optical transmission range for the first time (see Sec. 6.4).

5.3.4 Tl₃AsSe₄

Three attempts were made to grow Tl₃AsSe₄ crystals from melts having the stoichiometric composition. In the first two efforts, only polycrystalline material was obtained, but the third boule contained a section about 1 cm in length that showed relatively low optical absorption. This crystal was obtained late in the program so that the only optical data obtained were the wavelengths of optical transmission. The transmission range is reported in Sec. 6.3.

5.3.5 TlArs₂

Severe difficulties arise in attempts to grow crystals of TlAsS₂ (and TlAsSe₂) because of the propensity of these compounds to form a glassy phase. We tried to circumvent the glassy phase of TlAsS₂ in the following manner. First, a TlAsS₂ glass was prepared by rapidly hilling TlAsS₂ liquid. Portions of this glass were then reloaded into a crystal-growing tube, the tube was sealed, and the charge remelted. The charge was then annealed for 17 hr at 175°C, during which time the TlAsS₂ glass partly crystallized. During the positioning of the crystal-growth tube in the growth furnace, we were cateful not to entirely melt the charge so that the crystalline nucleii present could act as seeds for further growth. Two growth runs were sade on this charge at 12 m 'day. In both cases the boule was polycrystalline. Large grains (1 to 3 cm in largest dimension) were present in the boule; the fact that such grains are never seen in

crystallized glass indicates that glass formation did not interfere with crystal growth. Single crystals could possibly be obtained by optimizing the related variables of growth rate and temperature gradient, but because of the low crystal symmetry, we did not continue efforts any further.

5.3.5 TlArSe,

The techniques discussed above for TlAsS₂ growth were \$150 tried for the crystal growth of TlAsS₂. We found, however, that when glasses of TlAsS₂ were annealed in crystal-growth tubes the tube invariably cracks and shatters — due apparently to expansion of the saterial upon solidification. Direct single crystal growth from a completely molten TlAsse₂ charge was tried but again the growth tube shattered when the boule was annealed in the lower furnace; the product was polycrystalline.

5.3.7 Ti₃As(S,Se)₃

A crystal growth run was made on the composition $Tl_3AsS_{1.5}Se_{1.5}$ in the solid-solution series. The respitant boule was polycryscalline; mereoever, a change in composition occurred as growth proceeded, indicating that the separation of the solidus and liquidus along the pseudobinary join $Tl_3AsS_3-Tl_3AsSe_3$ is sufficient so as to seriously interfere with crystal growth.

6. OPTICAL PROPERTIES OF T1-As-Se-S COMPOUNDS

6.1 Tl3Asbe3

The detailed knowledge of phase equilibria in the system T1-As-Se eveloped through thermal analysis techniques has led to the growth of large ${\rm T1}_3{\rm AsSe}_3$ crystals of excellent optical quality.

Refractive indices were measured from 1.55 µm to 10.6 µm on an oriented prism of Tl₃AsSe₃ cut from Boule TASE-BR-3, which we estimated to have the best quality. The indices were measured by the method of perpendicular incidence on a Gaertner L-114 spectrometer, using chopped light from a cungsten filament, with calibrated narrow band filters to select wavelengths, and a cooled InSb detector. The estimated accuracy of the measurements is ± 0.003. The results of the refractive index measurements are shown in Fig. 19, where they have been fitted with Sellmeier curves of the type

$$n^2 - 1 = \frac{A}{1 - (\frac{\lambda}{\lambda}V)^2} + \frac{B}{1 - (\frac{\lambda}{\lambda}R)^2}$$

For 'o and n_e , $\lambda_V = 0.445 \, \mu m$, and $\lambda_R = 20 \, \mu m$. For n_o , $A_o = 10.125$, $B_c = 0.10$. for n_e , $A_e = 8.96$, $B_e = -0.05$.

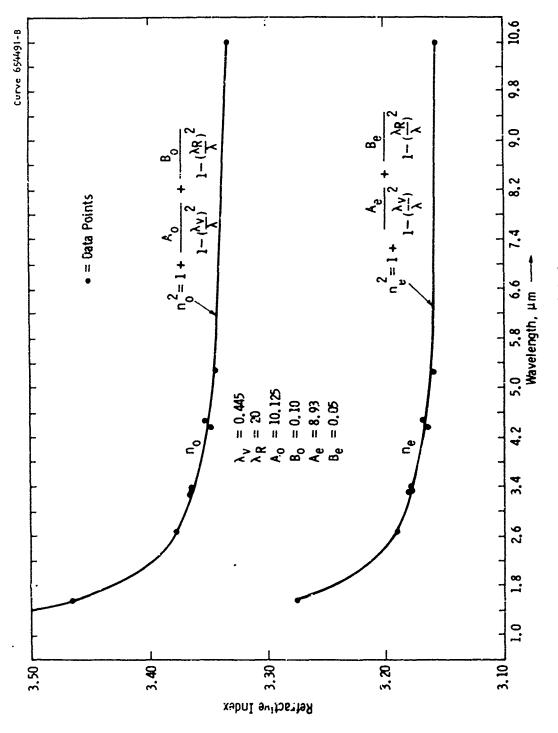


Fig. 19—The refractive indices of ${\rm IL_3As~Se_3}$. Crystal TASE-BR-3

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These indices are slightly larger than those measured on our original ${\rm Tl}_3{\rm AsSe}_3$ samples 10 ; the biretringence and dispersion have not changed much, however, so there has been little change in the phase-matching conditions.

Using these slightly revised values for the refractive indices, we have recalculated some of the phase matching curves for Tl_3AsSe_3 . In Fig. 20, we show the phase match angle, θ_m , as a function of wavelength of the fundamental, λ_0 , for Type-I phase matched second harmonic generation in Tl_3AsSe_3 . We see that θ_m ranges from 48° for $\lambda_0=3.0~\mu m$ to a minimum of about 14.7° at 11 μm . In the 10.6 μm region, the curve is relatively flat, implying that it should be possible to phase match the Type I SHG process for the many rotational-vibrational transitions of a CO_2 laser at the same angle in the Tl_3AsSe_3 crystal. The birefringence angle, ρ , is large so he halk-off losses will be high.

In Fig. 21 are shorn Type I phase matching curves for optical parametric generation, calculated on the basis of the more recent refractive index data. The curves are slightly changed from our original ones 10 ; for instance, phase matching for 2.1 µm-pumped degenerate optical parametric oscillation at 4.2 µm is expected to take place at $\theta_{\rm m}$ = 29.7°, compared to our originally calculated value of $\theta_{\rm m}$ = 30.2°. Curves for pumping at 1.833 µm (Nd:YAG laser) and 2.795 µm. (NF laser) are also shown, and the curves have been extended to near the limits of transparency at 18 µm.

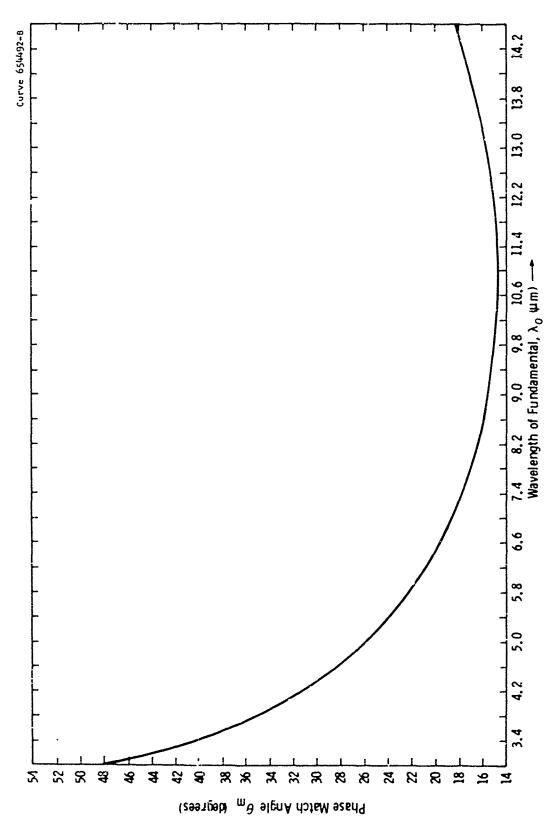


Fig. 20-Calculated phase match angle vs. wavelength of fundamental for Type I Phase-Matched Cecond Harmonic Generation in It₃ As Se₃ (Crystal # TASE- BR-3)

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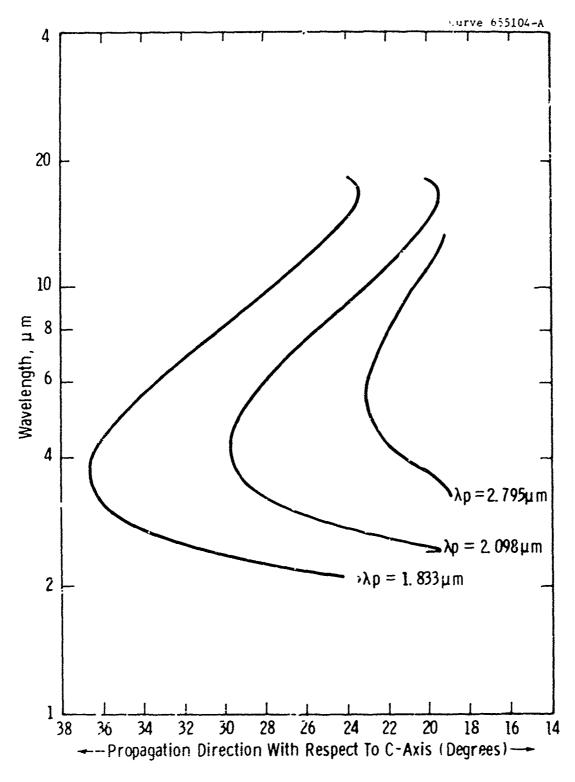


Fig. 21—Phase matching curves (Type I) for optical parametric oscillation in ${\rm TL}_3{\rm As~Se}_3$

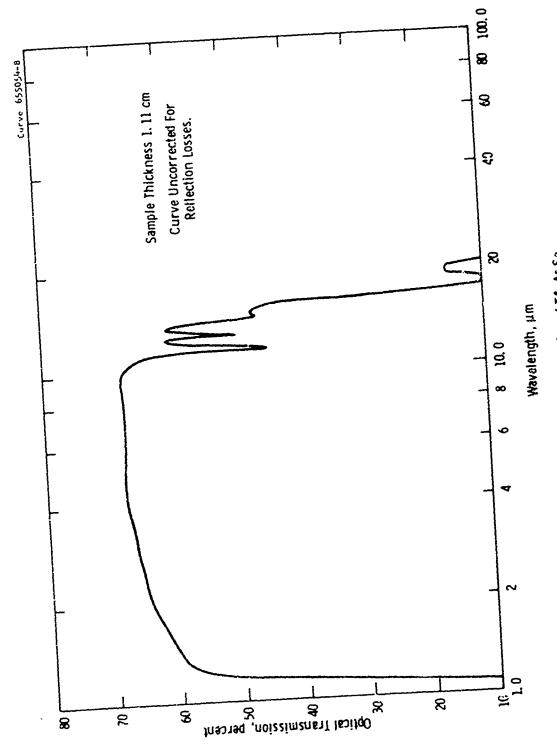
6.2 Tl3AsSe4

The optical transmission of Tl_3AsSe_4 is shown in Fig. 22. The band edge is at about 1.15 µm, and the transparency range extends to about 17 µm, alt ough two-phonon absorption peaks at 11.6 µm and 12.8 µm reduce transmission in the region beyond 10 µm.

Since Tl₃AsSe₄ is expected to be structurally similar to
Tl₃AsS₄, which is centric, Tl₃AsSe₄ is not expected to exhibit piezoelectric or second order nonlinear optical behavior. Criented samples
are being prepared for refractive index and acousto-optic measurements.

6.3 <u>Tl</u>3AsS3

As indicated in preceding sections, considerable difficulty has been experienced in growing single crystal Tl₃AsS₃, because of the closeness of eutectics to Tl₃AsS₃ in the Tl-'s-S system. A small section of Tl₃AsS₃ boule TASS-BR-5, a 1.07 cm thick section about 0.5 cm long near the seed end, as shown in Fig. 23, exhibited reasonable transmission at 2.1 µm. A 3.82 mm thick piece of this section was used for optical transmission measurements, with the results shown in Fig. 24. We see that the band edge of Tl₃AsS₃ is at about 0.9 µm, with transmission extending to 12.5 µm, although absorption losses of 0.5 to 1.0 cm⁻¹ can be expected in the 10-11 µm region because of two-phonon absorption. Another prominent feature is the band tail extending from 1 µm to about 4 µm, possibly a result of scattering or absorption in inclusions of other phases of the Tl-As-S system.



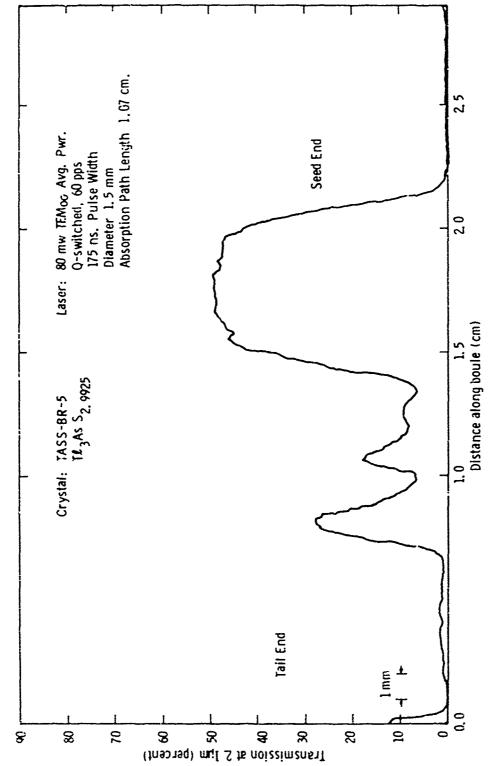


Fig. 23 - Optical transmission at 2. Iµm atong an as-grown boule of ${\rm 1L_3As~S_3}$

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The position of the band edge at 0.9 μm is a very promising indication for Tl_3AsS_3 . It implies the possibility that the refractive indices and hence nonlinear optical coefficient of Tl_3AsS_3 lie intermediate between proustite (Ag_3AsS_3) and Tl_3AsSe_3 . For optical frequency up-conversion and mixing experiments, this band edge at 0.9 μm would also allow us access to the region of S-1 photomultiplier sensitivity.

Unfortunately, we were unable to obtain oriented prisms of Tl₃AsS₃ from the above "good" section of the boule. Apparently, this section was still polycrystalline, since we could not obtain clear Laue backscatter patterns for x-ray orientation.

6.4 TIASS

We have indicated previously the difficulty in growing single crystal ${\rm TlAsS}_2$ because of 1.3 propensity to form a glassy phase. Optical transmission measurements were attempted on some sections of glassy ${\rm TlAsS}_2$; but the material was opaque in the thicknesses used (2-3 mm).

6.5 Tl3AsS4

The optical transmission of TL3As54 ranges from about 0.5 up to 12 um. 14

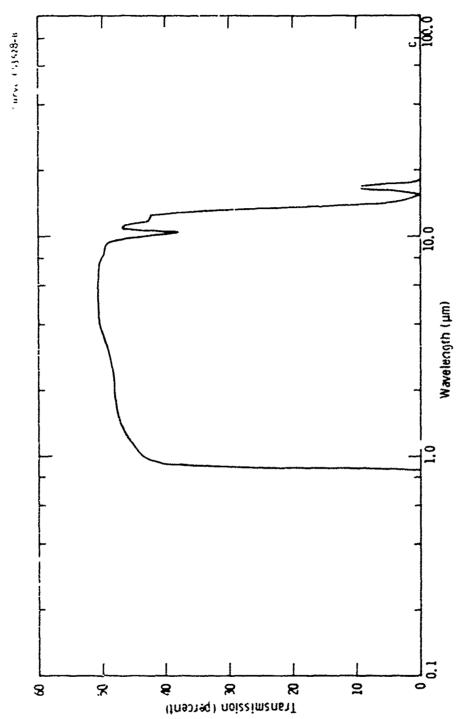


Fig. 24 -0, tical transmission vs wavelength for single crystal I t_3 AsS3. Sample thickness 3.82 mm. Curve uncorrected for reflection losses.

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7. PIEZOELECTRIC, ACOUSTIC, AND ACOUSTO-OPTIC PROPERTIES

7.1 <u>Tl₃AsSe₃</u>

Piezoelectric tests were performed on an oriented sample of Tl₃AsSe₃ cut from boule TASE-BR-2. The optical quality of this section was not the best; optical losses at 2.1 ,m were of the order of 0.3 cm⁻¹. Silver paste electrodes were placed on a-faces [100] or b-faces [010] and these piezoelectric elements were connected in series with a 100% resistor. A variable frequency RF generator (HP 651A) was connected across the resistor and crystal in series, and variations in RF voltage across the head resistor for constant applied voltage were monitored with an oscilloscope. A frequency counter (GR 1192) was used to measure the crystal resonance and anticesonance frequencies. This technique is not as sensitive as the standard technique (for example, Standard 58 IRE 14.51) lt which involves the use of an admittance bridge to determinate resonance and antiresonance frequencies, but it is sufficiently accurate to provide initial estimates of electromechanical coupling factors.

The electromechanical coupling factor, k, of a piezoclectric material is a dimensionless factor ranging from zero to one which indicates the efficiency with which mechanical energy is converted inco

electrical energy and vice versa. ¹¹ In general, k depends on mode of vibration and the orientation of the crystal; for an efficient piezo-electric material such as lithium niobate, k ranges from 0.0 to about 0.7.

For the crystal orientations considered above, the primary modes excited are thickness shear modes, for which the coupling coefficient is k_{15} . The coupling factor k_{15} can be determined experimentally by measuring the difference between the trequencies of piezcelectric resonance and antiresonance for an oriented plate or bar driven by an RF field applied to electrodes on the crystal surface. The effective coupling factor is related to the resonance frequency (f_r) and antiresonance frequency (f_a) of the plate by 13

$$k_{15}^2 = (\frac{\pi}{2} \frac{f}{f_a}) \cot (\frac{\pi}{2} \frac{f}{f_a})$$

In Table 5 are given the frequency values as experimentally determined for the strongest modes of an X-cut plate of ${\rm Tl}_3{\rm AsSe}_3$, and the coupling factors and frequency constant, N, determined from these measurements. The frequency constant N is defined as the product of series resonant frequency and plate thickness 11 , and is related to an effective elastic modulus, \tilde{c} for the mode, and the crystal density o, by

$$N = f_r t = \frac{F}{2} \sqrt{\frac{c}{c}}.$$

F is a numerical factor related to the eigenvalue of the mode. We can get a numerical value of \bar{c} from N and our known value for ρ (= 7.83 gm/cm³).

TABLE 5

Some Piezoelectric and Elastic Constants for Tl₃AsSe₃ at Room Temperature

Crystal Orientation	f r (kHz)	f a (kHz)	$k_{15} = \left[\frac{1}{2} \frac{f_r}{f_a} \cot \frac{\pi}{2} \frac{f_r}{f_a}\right]^{\frac{1}{2}}$	N = f _r t (Hz-M)	(10 ¹⁰ Nt ×2)
x-cut Tl3AsSe3	148.301	148.718	0.083	524.99	0.216
	154.252	154.565	0.071	546.61	0.234
y-cut Tl ₃ AsSe ₃	133.609	133.793	0.046	627.83	0.309
LiNbO ₃ (typical)			0 + 0.6	2000	1.5 + 25

The Q's $(\frac{y}{4y})$ of the two resonances for the x-cut case were about 300 and 110, respectively.

in comparison with equivalent values for a very efficient piezoelectric such as LiNbO3, the values so far determined for Tl3A3Se3 indicate that it is not a highly efficient piezoelectric material; if Tl3AsSe3 is considered for use as an ultrasonic transducer, for instance, we could expect efficiencies of perhaps 5 to 16%, compared to 60% in LiNbO3. The coupling factors for Tl3AsSe3 are thus of the same order of magnitude as those of quartz.

Acoustic velocity and loss measurements were made on a sample of single crystal Tl_3AsSe_3 using conventional pulse-echo techniques, with the results shown in Table 6. Longitudinal wave velocities are of the order of 2 x 10^5 cm/sec, and shear wave velocities are of the order of 1 x 10^5 cm/sec, with a very slight dependence on shear wave polarization.

TABLE 6 $\label{eq:table_form} \mbox{Measured Acoustic Properties of ${\rm Tl}_3{\rm AsSe}_3$}$

Propagation ;	Velo	cities (in cm/s	ec)
Direction	Longitudinal	Shear	Shear Polarization
	1.98 x 10 ⁵	1.05 x 10 ⁵	. ъ
a-Axis[100]	1.90 X 10	1.05 x 10 ⁵	, c
	2.15 x 10 ⁵	1.05 x 10 ⁵	il a
b-ixis(010)	2.17 x 10	1.00 x 10 ⁵	. c
	2.14 x 10 ⁵	1.01 x 10 ⁵	;
c-Axis[001]	2.14 X 10	1.01 x 10 ⁵	j b

Acoustic losses are fairly low; for longitudinal waves at 30 MHz, the loss is $0.18 \text{ db/}\mu\text{sec}$, while for shear waves at 20 MHz, the loss is $0.057 \text{ db/}\mu\text{sec}$.

Using the measured values of refractive index, density, and acoustic velocities, we may estimate acousto-optic figures of merit for Tl_3AsSe_3 . A figure of merit which indicates the efficiency of a material as an acousto-optic modulator is $M_2 = \frac{6p^2}{cv^3}$, where n is the refractive index, p the profuelastic coefficient, c the density, and v the acoustic velocity. In Table 7, we compare estimated and measured values for the M_2 's of Tl_3AsSe_3 ; elative to those of SiO_2 , at 3.39 Lm. We assume for the theoretical estimates that the photoelastic coefficients, p, in the two materials are equal, so that

TABLE 7

Calculated and Measured Acousto-Optic Figures of Merit, M_2

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N + chartol			Waves Down c-axis		S	Waves Down c-axís	wn c-axis	
יים רבן דמד	n(3.39 µm)	n(3.39 µm) v(cm/sec) M ₂ (calc; M ₂ (meas;	M ₂ (calc)	M. (meas)	(mu 95.5)n	n(3.29 µm) v(cm/sec) M ₂ (calc) M ₂ (meas)	M ₂ (calc)	M ₂ (meas)
Tl ₃ AsSe ₃ (p = 7.83 gm/cm ³)	3.24	2.14 × 10 ⁵	871	150	3.24	1.01 × 10 ⁵	8300	510
0.02 ($\nu = 2.202 \text{gm/cm}^3$)	1.41	5.9 × 10 ⁵	-	rd	1.41	5.9 × 10 ⁵	H	г

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$$\frac{\frac{M_{2}(\tilde{r}_{1}^{1}3^{\text{AsSe}_{3}})}{M_{2}(\tilde{s}_{10}^{2})} = \frac{n_{T_{1}^{1}3^{\text{AsSe}_{3}}}^{6}}{n_{S_{10}^{2}}^{6}} \cdot \frac{(\rho v^{3})_{S_{10}^{2}}}{(\rho v^{3})_{T_{1}^{3}^{\text{AsSe}_{3}}}}$$

The ratio by which the measured values of the above M2's depart from the theoretical values is in itself a determination of the relative values of the corresponding photoelastic coefficients; thus,

$$\frac{p_{23}(T1_3^{AsSe_3)}}{p_{31}(S10_2)} - \sqrt{\frac{150}{871}} = 0.41 ;$$

$$\frac{p_{44}(T_{3}^{1}AsSe_{3})}{p_{31}(SiO_{2})} = \sqrt{\frac{510}{3300}} = 0.25.$$

The M₂ value of 510 measured for shear waves is very high. Of presently available infrared materials, only Germanium (M₂ = 540), As₂S₃ glass (M₂ = 200-300) and Tl₃AsS₄ (M₂ = 338) are as efficient as acousto-optic modulators.

7.2 $\underline{\text{T1}_3} \underline{\text{AsS}_3}$

Tests run on an unoriented 3.62 mm thick plate of ${\rm Tl}_3{\rm AsS}_3$ indicated strong resonances at 161 kHz and 168 kHz. This corresponds to sound velocities of about 1.2 x 10^5 cm/sec, which is typical for shear waves in sulfosalt materials. Coupling factors were not measured at the time.

This indication of piezoelectric behavior also implies that the structure of Tl₃AsS₃ is acentric, and hence it possesses non-zero second order optical nonlinear susceptibilities. As indicated previously, crystal growth problems have prevented us from obtaining an oriented single crystal section of Tl₃AsS₃ for refractive index and nonlinear optical measurements.

7.3 T13AsS4

Acoustic velocities and acousto-optic figures of merit for Tl_3AsS_4 have been reported previously in the literature. ¹⁴ Longitudinal mode velocities are of the order of 2.2 x 10^5 cm/sec, and shear mode velocities are about 1.2 x 10^5 cm/sec. Acousto-optic figures of merit, M_2 , range from 166 to 295 at 3.39 μm .

8. USEFULNESS OF T1-As-S-Se COMPOUNDS IN CPTICAL AND ACOUSTO-OPTICAL DEVICES

8.1 Irtroduction

Conclusions are drawn in this section relative to the usefulness of the compounds studied during this contract for optical and acousto-optical devices. Two main types of device application are treated --

- optical parametric oscillation
- acousto-optical applications.

8.2 Optical Parametric Oscillation

8.2.1 Desirability of a 2 mm-Pumped Optical Parametric Oscillator System

At present, tunable coherent optical sources in the 3 to 5 um spectral region are limited in number, and their output powers and efficiencies are very low. With the frequency-doubled Nd:YAG laser-pumped OPO operating with LiNbO₃ as the nonlinear meterial, ¹⁵ the 3.0 ± 3.5 um spectral range can be covered, with average power output of about 5 to 10 mW, and output pulse peak powers of the order of 80 to 150 watts. The ultimate efficiency of this system is limited; the pump wavelength is 0.532 µm, so that the best overall conversion efficiency to 4 µm to be expected for a singly resonant system is $\eta = \frac{1}{100} = \frac{0.532}{4} = 13\%$, because the idler output at 1.063 µm is not

in the 3 to 5 um region. Operation of this system at wavelengths longer than 3.5 µm is impossible because of the onset of intrinsic absorption in LiNbO, in that spectral region. In a dye laser mixing experiment in which a ruby laser-pumped dye laser and the ruby laser itself were mixed in a LiIO, crystal, Meltzer and Goldberg 16 generated outputs tunable through the 4.1 to 5.2 µm region, with peak powers of the order of 100 W. The efficiency of this system is very low because of the low inherent efficiency of both the ruby and dye lasers. Goldberg 17 has also attained tunable outputs in the 3.8 to 4.2 μm region in a singly resonant OPC on $LiIO_3$, using a Nd:YAG laser at 1.06 μm as the pump. In that system, however, the output at 4 µm was erratic because LiIO, is lossy at 4 µm, and pump oulse energies high enough to cause thermal defocusing and damage in the ${\rm LiIO_3}$ crystal were required. Most recently, Hanna and his colleagues at the University of Southempton in England have successfully operated an OPO tunable laser from 1.22 to 8.5 pm, using proustite (Ag₃AsS₃) as the nonlinear crystal, pumped as 1.05 um by a Md:YAG laser. 18 Teak powers of about 100 W were obtained in a bandwidth of about 1 cm⁻¹ at 4.5 µm. In this oscillator, the ultimate attainable conversion efficiency would be n = 1.06/4.0 # 2' -, provided it is operated in a singly resonant configuration. The threshold power density is quoted by Hanna et al. as about 5 MW/cm2; this seems to be unusually low, even though they experienced a roundtrip rignal loss of only 20% and used a very abort optical cavity. This power density, it correct, is well below the reported damage treeshold for $A_{k_3}A_{k_3}$, which is about 20 NW/co 2 at 1.06 µm.

The threshold power densities observed by Hanna et al. at 1.06 µm in Ag_3AsS_3 can immediately be used to show that attempts to develop a proustite (Ag_3AsS_3) oscillator at 2.1 µm would not be very successful. For confocal focusing, the parametric gain coefficient is inversely proportional to the cube of the pump wavelength: $\Gamma^2 = 1/\lambda^3 p$. Thus, the gain would be $(2.1 \text{ µm}/1.06 \text{ µm})^3 = 7.7 \text{ times lower in the}$ 2.1 µm-pumped system, bringing the required threshold at 2.1 µm above the damage threshold of 20 MW/cm². The existing evidence thus indicates that a 2.1 µm-pumped OPO based on $Ag_3A \cdot S_3$ would operate only erratically and be severely limited by optical damage problems. A nonlinear optical materials with higher nonlinear susceptibility and higher damage threshold than proustite is thus needed for a 2.1 µm-pumped oscillator. In a subsequent section, we will discuss the applicability of the higher susceptibility nonlinear optical materials available, including Tl_3AsSe_3 .

Other techniques for attaining tunable outputs in the 3 to 5 am region may include various pump-tuned parametric oscillators or the mixing in an infrared nonlinear crystal of an infrared pump with the tuned output of an infrared GPO, ¹⁹ and dye laser mixing in proustire. ²⁶ While such systems are still relatively inefficient, mixing efficiencies in some cases can be good.

8.2.2 Comparison of Materials for 2 µm-Pumped OPO Action: Advantages of Tl₃AsSe₃

8.2.2.1 Requirements

Nonlinear optical materials for parametric oscillator applications must meet many requirements, among which are:

- A. Transparency throughout a wavelength region including pump, signal, and idler wavelengths.
- B. Reasonably high nonlinear optical susceptibilities.
- C. Capability of being phase-matched for the wavelength range of parametric operation desired.
- D. Optical damage thresholds higher than the power densities needed for efficient parametric conversion.
- E. Availability as reasonably large single crystals of good optical quality.

A convenient method of comparing nonlinear materials on the basis of requirements A and B above was discussed by Harris, 21 who noted that in a parametric oscillator the conversion efficiency is proportional to a certain combination of materials parameters, d^2/n^3 , where d is the effective nonlinear optical susceptibility of the materials for the particular parametric process, and n is roughly an average refractive index. Strictly speaking, d may vary considerably even for the same material, depending on the process considered and the wavelength regions involved; nevertheless, the "figure of merit" d²/n³ gives a rough comparison of the effectiveness of various materials in parametric processes. Harris plotted d^2/n^2 for materials versus their useful transparency region, as shown in Fig. 25. We have added to Harris' figure the parameters for some recently developed materials, and included some recent corrections to previously measured susceptibilities. If we concentrate first on materials with a 2 to 5 µm region of transparency, we see that of those materials listed, this

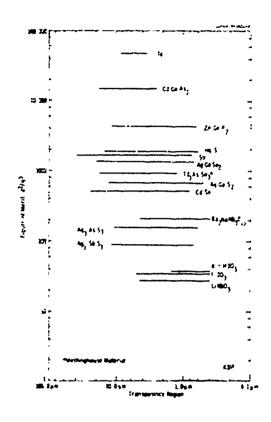


Fig. 25 — Optical parametric figure of merit, d^2/n^3 , and transparency region for conlinear optical materials.

transparency requirement eliminates KDP, LiNbO₃, α -HIO₃, Ba₂NaNb₅O₁₅, CdGeAs₂ and Te. LiNbO₂ and Ba₂NaNb₅O₁₅ actually are transparent to about 5 µm; however, they are too lossy in the region above 4.5 µm to be considered for parametric applications in the entire 4 to 5 µm region. In addition, LiNbO₃ of normal composition cannot be phase matched for a 2.1 µm Ho:YAG pumped oscillator; the d-coefficients of these two materials are also considerably lower than those of some of the other materials.

Of the remaining materials, we see that the chalcopyrites ${\rm ZnGeP}_2$ and ${\rm AgGaS}_2$ appear to have reasonably large figures of merit, although we have calculated the figure of merit for ${\rm AgGaS}_2$ on the basis of the initially reported measurement 22 of ${\rm d(AgGaS}_2) = 0.42 \ {\rm d(GaAs)}$, which later evidence indicates might be too high by a factor of three. 23 We will see below that ${\rm ZnGeP}_2$ is not phase matchable over the entire 4 to 5 µm region for 2.1 µm pumping, while ${\rm AgGaS}_2$ is phase matchable for that process.

Recent work by Boyd and his colleagues 24 indicated that the chalcopyrite AgGaSe₂ has considerable promise as a nonlinear optical material. It should allow phase-matched 2.1 µm + 4.1 µm conversion at about 48° to the optic axis, 24 and has a high figure of merit (See Fig. 28). As is the case with many of the chalcopyrites, AgGaSe₂ is difficult to grow in useful crystal sizes of good optical quality. Boyd et al. reported losses of the order of 4 to 5 cm⁻¹ over the entire transparency range of the crystal. 23 Recently, we have been able to grow AgGaSe₂ as reasonably large (0.04 x 0.4 x 0.6 cm) single crystals of lower loss (a ~ 0.5 cm⁻¹ at 2.1 µm). This loss is still too high for use in a parametric oscillator.

HgS and Se have attractively high figures of merit; we have calculated phase matching conditions for HgS (positive uniaxial. Type II phase matching) and find that it does not phase match for 2 µm-pumped degenerate oscillator operation ($\lambda_p = 2 \mu m + \lambda_s = \lambda_1 = 4 \mu m$) at any angle. Although we have not calculated phase matching conditions for Se, it is positive birefringent and the birefringence (~ 0.81)

appears to be too large to allow phase matching in the 2 to 5 µm region. Se and HgS have also been extremely hard to grow as usable size crystals of good optical quality.

CdSe is an attractive material from the point of view of the nonlinear figure of merit ${\rm d}^2/{\rm n}^3$, and availability in crystals of good quality and size; unfortunately, as we shall see, it does not phase match properly for 2.1 μ m-pumped oscillation in the 4 to 5 μ m region, although it has been usefu! for oscillation in the 2.0 to 2.3 μ m and 9 to 13 μ m regions when pumped with a 1.833 μ m source. ²⁵

The sulfosalt materials Tl₃AsSe₃, Ag₃AsS₃, and Ag₃SbS₃ all appear to be phase matchable, as we will see below. Tl₃AsSe₃ has the highest figure of merit and should provide the lowest threshold of all of the materials considered in this discussion.

Lilo₃ is also phase matchable for the 2.1 µm pumped parametric oscillator process, and its transparency region extends to 5 µm, although there is a small absorption band for the ordinary ray near 4.2 µm which could cause some difficulty. The fact that the nonlinear susceptibility of Lilo₃ is much lower than the above materials means that very high pump power densities will be required to reach the oscillator threshold if Lilo₃ is used.

Details of the phase matching considerations are given in Section 8.2.2.2; in Section 8.2.2.3 we will summarize all of the materials considerations.

8.2.2.2 Phase Matching Considerations

(i) Chalcopyrites

ZnGeP₂ is very attractive from the point of view of its transparency and high nonlinear optical figure of merit, but unfortunately the refractive index data of Boyd²⁶ indicate that a 2.1 µm pump cannot be phase-matched efficiently to parametrically generate radiation anywhere between 3.4 µm and 5.8 µm, although the 2.1 to 3.4 µm and 5.8 to 12 µm regions should be accessible with a 2.1 µm pump (Fig. 26). In addition to this problem, the state of the art in growing ZnGeP₂ is not very satisfactory; for some as yet unknown reason, the band edge extends into the 2 µm region, producing unacceptable loss (as high as a . w cm⁻¹) for the pump radiation.²⁶

AgGaS₂, according to recent measurements of Boyd et al., ²³ is phase matchable (Type I, 0 + 0 + e) for 2.1 µm pumped oscillation into the 4 to 5 µm region, at about 30.5° to the optic axis (Fig. 27). Unfortunately, AgGaS₂ in its present state of development also exhibits large losses ($\frac{1}{2}$ 1.0 cm⁻¹) at 2.1 µm and about 1 cm⁻¹ in the 4 to 5 µm region. The losses are partly due to absorption and partly due to scattering in cracks and voids in the material.

AgGaSe $_2$ should be phase matchable for 2.1 \pm n + 4.1 \pm n frequency conversion, as we may see from Figs. 28 and 29, which are reproduced from the paper of Boyd et al. on ternary selendes.

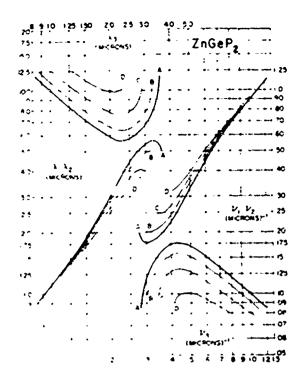


Figure 26 -- Three-frequency phase matching for ZnGeP2 indicating v_1 and v_2 (or wavelength λ_1 and λ_2) vs the pump frequency v_3 (or wavelength λ_3). (Ref. 26).

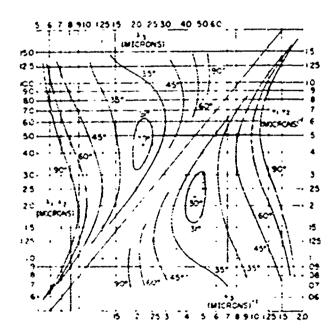


Figure 27 — Type-1 (o + o + e) three-frequency phase matching for AgGaS2, indicating v1 and \(\lambda\)2 versus pump frequency v3 (lower right) or \(\lambda\)1 and \(\lambda\)2 versus \(\lambda\)3 (upper loft). (Ref. 23).

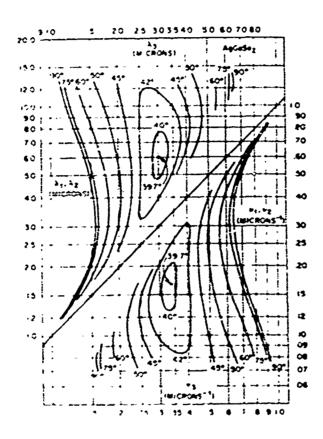


Figure 28 --- Type-1 (o + o + e) three-frequency phase matching for AgGaSe2, indicating v_1 and v_2 versus pump frequency v_3 (lower right) or λ_1 and λ_2 versus λ_3 (upper left). (Ref. 24).

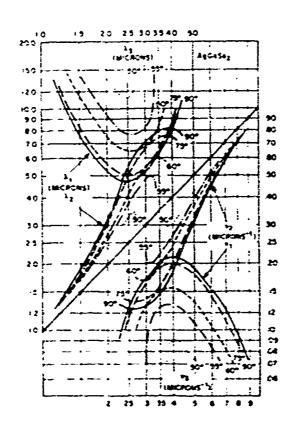


Figure 29 — Type-2 (e + o + o) three-frequency phase matching for AgGaSe2, indicating v₁ and .2 versus pump frequency v₃ (lower right) or v₁ and l₂ versus l₃ (upper left). (Ref. 24).

(ii) CdSe

A phase matching co we for CdSe pumped at 2.06 μ m is shown in Fig. 30. The curve was calculated with pumping by $\pi o: SOAP$ ($\chi_p = 2.06 \ \mu m$) in mind, but the general features will not be much different for Ho:YAG pumping ($\chi_p = 2.098 \ \mu m$). The 3.1 to 6.4 μ m region is completely inaccessible for phase-matched parametric conversion. An interesting feature is that 90 deg phase matching of conversion of 2.1 μ m radiation to 3.05 μ m and 6.40 μ m radiation should be possible, which implies very low thresholds for this process. Also note that large angle phase matching for conversion and continuous tuning in the 2.5 to 3.0 μ m and 6.4 to 13 μ m regions is possible in CdSe pumped at 2 μ m. Since $\pi_e = \pi_0 > 0$ (positive birefringence), Type II ($\pi_e = 0.00$) phase matching is required.

Byer and Herbst 25 have made use of these excellent properties of CdSe by constructing a tunable CdSe oscillator with outputs in the 2.2 to 2.3 µm and 9 to 13 µm region.

(iii) The Sulfosalt Materials

Figures 31 and 21 show phase matching curves for proustite 27 (Ag₃AsS₃) and thallium arsenic selenide 27 (Tl₃AsSe₃). We have not calculated curves for Ag₃SbS₃ but we expect them to be somewhat like those of Ag₃AsS₃ (the refractive index data indicate that phasematched degenerate operation with $\frac{1}{p}$ = 2.1 μ m will occur in Ag₃SbS₃ at an angle of about 27 deg to the crystal c-axis). 28

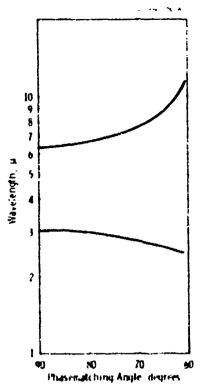


Figure 30 -- Theoretical tuning curve for optical parametric oscillation in CdSe, for a pump wavelength λ_p = 2.06 μ m. (Ref. 27)

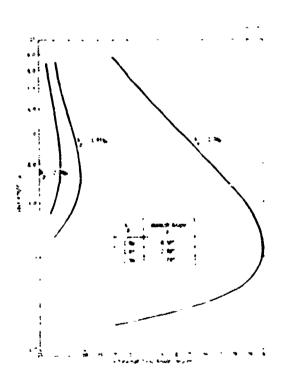


Figure 31 -- Theoretical tuning curves for optical parametric oscillation in proustite (Ag3AsS3), pump wavelength ^{3}p a parameter. (Ref. 27).

Figure 31 illustrates that phase-matched tunable oscillation for a 2.1 µm pump in Ag AsS will occur at phase match angles of 16.5 to 15.5 deg; the steep iss of the curve also indicates that the tuning with angle will be very rapid. The birefringence angle a, which limits the effective length of the crystal for a given beam spot size, is 2.89 deg at 2.1 µm.

Phase matching curves for Tl₃AsSe₃ (Fig. 21) indicate that phase matching should occur for 2.1 µm pumping at angles of 30 to 24 deg. The birefringence angle, ., is about the same as for Ag₃AsS₃. Again, the steepness of the tuning curve for 2.1 µm pumping implies that rapid tuning with angular displacement will be possible. However, this also implies that a large oscillator bandwidth will result.

(iv) Lilo,

Figure 32 shows tuning curves ²⁷ calculated for LiIO₃. LiIO₃ is matchable for a 2.1 µm pumped oscillator, but the idler wavelength comes close to the absorption edge; this may present problems in the 4.5 to 5.0 µm region. The tuning curve is also very steep, as was the case for Tl₃AsSe₃ and Ag₃AsS₃. The birefringence angle p is also larger for LiIO₃ than for Tl₃AsSe₃, 3.74 deg as against 2.98 deg. The parametric gain is roughly proportional to 1/c² for a wide range of focusing conditions, thus the parametric gain in Tl₃AsSe₃ will be over 50% greater than in LiIO₃ due to this factor alone. An even greater advantage of Tl₃AsSe₃ over LiIO₃ is the fact that the nonlinear optical coefficient, d, of Tl₃AsSe₃ is about seven times larger than that of

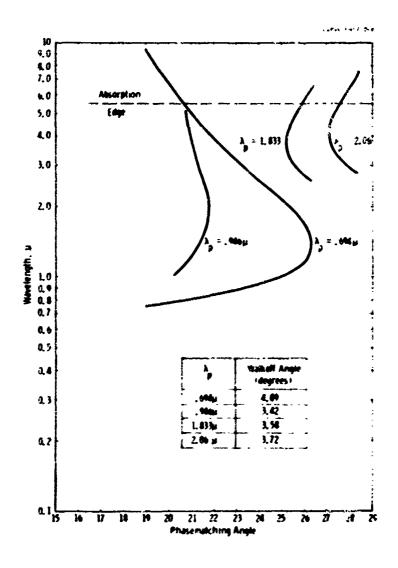


Figure 32 -- Theoretical tuning curves for optical parametric oscillation in Li103, pump wavelength λ_p a parameter (Ref. 27).

Mary D. P. Care

Properties of Candidate Norllnear Optical Materials for 2.1 um Pumped Parametric Oscillation in the 4 to 5 um Region Table 3

The state of the s

Linbo ₃ Al Lilo ₃ Ag ₃ As ₃	for 2.1 Lm . 4-5 um?	d ² /n ³ (KDP=1)	Sizes Available (cm)	Optical Damage Threshold
Liio; Ag ₃ as ₃ Ag,sbs,	No Also lossy at 4.5 um	58	2 x 2 x 10	40 MW/cm ² (Long Pulse) 100 MW/cm ² (ns Pulse)
Ag 3As S 3 Ag , Sh S ,	Yes	35	5 x 5 x 10	125 MW/cm ²
A£,ShS,	Yes	160	1 x 1 x 5	12-40 MW/on
7	Yes	170	1 x 1 x 5	14-20 MW/cm ²
Ba2NaNb5015	? Lossy at 4.5 um	210	0.5 × 0.5 × 0.5	1 MW/cm ²
CdS.	Š	520	1 x 1 x 5	60 MW/cm ²
ARC&S2	Yes	680*(-,707)	0.3 × 0.3 × 0.3	12-26 MW/cm ²
Tl3A#Se3##	Yes	930	0.8 × 0.8 × 2	32 MW/cm ²
Se	? (Probably Not)	1700	0.2 × 0.2 × 1	e
Fg.S	£	1900	0.2 × 0.2 × 3	•
2mieP ₂	&	4300	0.3 x 0.3 x 0.3	>3 MW/cm ²
AgGaSe2	Yes	1350	0.4 × 0.4 × 0.6	>10 MW/cm ²

Assumes $d(AgGaS_2) = 0.42 d(GaAs)$, which may be a factor of 3 too high.

^{**} Westinghouse miterial.

LiIO₃; the data of Fig. 32 imply that the gain per unit pump power in Tl_3AsSe_3 should be at least 30 times higher than that in a sample of LiIO₃ of the same length, not even including the $1/\rho^2$ factor above.

8.2.2.3 Summary of Survey Results

Table 8 summarizes the results of the preceding surveys, including only those materials exhibiting reasonable transparency throughout the entire 2 to 5 µm region. The summary shows that, of the phase matchable materials, Tl₃AsSe₃ and AgGaSe₂ possess by far the largest figures of merit. Of these two potentially useful materials, only Tl₃AsSe₃ is available as good quality single crystals of large size. Its most serious rival is probably LiIO₃, which is a factor of 30 worse in figure of merit, but better by the same factor of 30 from point of view of damage threshold; LiIO₃, however, may also be somewhat lossy near 5 µm, which would degrade oscillator performance.

8.3 Acousto-Optic Devices

8.3.1 Acousto-Optic Modulators

The high acousto-optic figure of merit and relatively low optical and acoustic losses observed in T1-As-S, Se compounds all indicate that these materials should be very useful as low-drive power acousto-optic modulators and beam scanners for infrared sources. In the following, we calculate some acoustic drive power requirements and other system characteristics for such applications.

8.3.1.1 External Modulation at 1.06 um

The fraction I/I of incident light intensity I which is deflected by a grating generated by an acoustic wave is given by $^{28}\,$

$$\frac{1}{I_0} = \sin^2 \frac{\Delta \phi}{2} \,, \tag{1}$$

where $\triangle \varphi$ is the amplitude of the grating, and is related to the applied acoustic power P_{AC} by

$$\Delta v = \tau \sqrt{\frac{2}{\lambda^2} \frac{L}{H} M_2 P_{AC}} . \qquad (2)$$

Here, L/H is the ratio of the acoustic beam length to its height, and is usually close to unity. The figure of merit, as we have previously noted, is

$$M_2 = \frac{n^6 p^2}{pv^3}$$
,

where n is the refractive index at the vacuum wavelength of the incident optical beam, p is the relevant photoelastic coefficient, ρ the density, and v the sound velocity in the material. For fused SiO₂, $M_2 = 1.51 \times 10^{-18} \, \sec^3/\text{gm}$.

For the case of external modulation of a 1.06 µm beam, we may use the above results to calculate the acoustic drive power requirement. We consider the requirement for delecting all of the incident power out of the beam, i.e., 100% modulation. Then,

$$\frac{\frac{1}{2}}{2} = \frac{2}{2}$$

$$P_{AC} = \frac{\frac{2}{2M_2}}{\frac{1}{2M_2}} \frac{H}{L} , \text{ or}$$

$$P_{AC} = \frac{\frac{2}{2M_2}}{\frac{2M_2}{2M_2}} \text{ for } H = L, \text{ which is the usual case.}$$
 (3)

With the value of M₂ for fused SiO₂ given above, Eq. (3) yields a drive power requirement of 372 wacts. External modulation at 100% at 1.06 µm using SiO₂ is therefore out of the question. With Tl₃AsS₄ as the modulator material, however, the drive power requirement will be reduced from this by a factor of 200 to 300, since the figure of merit of Tl₃AsS₄ is this much larger than that of SiO₂ near 1 µm. ²⁹ The required acoustic drive power with Tl₃AsS₄ will thus be only about 1 to 2 warts, depending on which photoelastic coefficient is used; such acoustic powers are readily generated in sulfosalt crystals by conventional techniques. For modulation at wavelengths longer than about 1.3 µm, interaction with shear waves in Tl₃AsSe₃ becomes the configuration of choice, since the figure of merit M₂ is, as seen in Sec. 7.1, about 500, which is even larger than that of Tl₃AsS₄. Germanium, another competitor, does not transmit below 2 µm.

8.3.1.2 Internal Modulation and Q-Switching at 1.06 pm

For Q-switching, the considerations are the same as those above, except that the amount of light deflected by the modulator now only needs to equal the amount by which single-pass gain in the laser rod exceeds its threshold value. For a typical Nd:YAG system operating with up to a few watts output, the gain per single pass ranges from 5% to 15%. Let us assume that the modulator must deflect about 10% of the incident light. Again, from Eqs. (1) and (2), we find, for the required acoustic power to Q-switch a Nd:YAG laser.

PAC = 15.5 watts for Sio2

 $P_{AC} = 0.05 \text{ to } 0.08 \text{ watts for } Tl_3AsS_4.$

Taking into account the coupling efficiencies of the acoustic transducers which would be needed, a Lindon transducer should provide coupling efficiencies ranging from 20% to 50%, depending on the mode desired. A reasonable estimate for the range of total power required from the RF generator to provide high data rate Q-switching would be 150 milliwatts to 400 milliwatts, if Tl₃AsS₄ were used as the modulator material. Since the acoustic loss in Tl₃AsS₄ is only about 1 dB/Lsec at 400 MHz, Q-switched pulse data rates of at least 500 MB/sec should be readily attainable with less than 0.5 watts average of RF drive power. Modelocking of a continuous Md:YAG laser will also be possible using this technique; even lower RF drive powers will be needed for that application, because when the modulation frequency is set close to the laser cavity longitudinal mode frequency interval, a much smaller loss perturbation than 100% is sufficient to cause mode locking.

Similarly, modulation of the laser with an internal Tl₃AsS₄ scousto-optic modulator would require much less power than the 1 to 2 watts calculated above for external modulation.

8.3.2 Electronically lumable Infrared Acousto-Optic Filters

For crystals of the triclinic and monoclinic systems, as well as for those in point groups 4, $\frac{7}{4}$, $\frac{4}{m}$, 3, $\frac{7}{3}$, $\frac{7}{3m}$ and 6, $\frac{7}{6}$, $\frac{6}{6m}$, an acoustic wave traveling collineatly with a light wave can diffract a portion of the light from its original polarization into an orthogonal

polarization. This scattering process is cumulative along the path of the beams in the crystal only provided that the acoustic frequency is adjusted so that the magnitude of the acoustic wave vector, kai, equals the magnitude of the difference between the wave vectors corresponding to the optical e-ray and o-ray, i.e.,

There is thus a one-to-one correspondence between the frequency of the light which experiences this cumulative polarization rotation and the frequency of the applied acoustic wave. This effect was used successfully by Harris and his co-workers to construct electronically tunable narrow band filters using ${\rm LiNbO}_3^{-30}$ and ${\rm CaRoO}_4^{-31}$.

It can be shown 32 that the acoustic power density P_A/A required to obtain theoretical 1002 peak transmittance of a filter of length L is given by

$$\frac{P_A}{A} = \frac{cv^3}{\sqrt{3}\sqrt{3}P_{11}^2} + \frac{c^2}{2L^2} = \frac{c^2}{2M_2L^2} , \qquad (4)$$

where $\frac{1}{2}$ is the optical wavelength at the peak of the filter transmission, and $M_2 = \frac{6p^2}{2^3}$ is the acousto-optic figure of merit which we have discussed previously. The important things to note in Eq. (4) are that the required acoustic power density increases rapidly, as the square of the optical wavelength, and that this required power density decreases as the material acousto-optic figure of merit increases.

With presently available cousto-optic materials such as $PbMoO_4^{-33}$. Caroo, and LiNbO3, the use of such filters is restricted to wavelengths

shorter than about 3 µm by two materials problems; the first is the fact that these oxides transmit only out to about 4.5 µm, and the second is the fact that their acousto-optic figures of merit are still so small that enormously high acoustic power densities are required at the longer wavelength. As an example, let us consider comparing Tl₃AsSe₃ and one of these new oxide materials, CaMoO₄, in this application, assuming we wish to achieve tuning in the 3-5 µm region. CaMoO₄ exhibits considerable absorption loss in the region 4-5 µm, while Tl₃AsSe₃ losses are only about 0.02 cm⁻¹ in this region, but the power density requirement is even a more severe limitation for CaMoO₄, as we will see. The figure of merit M₂ of CaMoO₄ is M₂ = 33.3 x 10⁻¹⁸ sec³/gm. Assuming that we have 2 cm long crystals, Eq. (4) above yields for the required acoustic power densities for 1002 transmission at a peak wavelength of 4 µm.

$$\frac{P_A}{A}$$
 (CaMoO₄) = 660 watts/cm²; tor Tl₃AsSe₃ we find

$$\frac{P_{A}}{A}$$
 (Tl₃AsSe₃) = 8.8 watts/cm². This assumes

 $M_2(Tl_3AsSe_3) = 150 M_2(SiO_2)$ as in Table 6.

The Tl₃AsSe₃ collinear acousto-optic filter at 4 µm would thus require seventy times lower power density than the CaMoO₄ filter at 4 µm. Using the theory first worked out by harris, one can show that this 2 cm long Tl₃AsSe₃ filter would have an acceptance angle of about 200 milliradians, a bandwidth of about 40 Å, and would require an acoustic drive frequency of about 100 MHz at 4 µm. Acoustic losses at 100 MHz in

 Tl_3AsSe_3 are equal to or less than 0.5 dB/usec for longitudinal waves, which would be used for this filter configuration. Since the velocity of longitudinal waves is about 2 x 10^5 cm/sec, the total acoustic loss down the 2 cm long filter will be only about 5 dB, which should be quite tolerable.

Tl₃AsSe₃ is thus a very attractive candidate as a material for use in infrared tunable acousto-optic filters.

Materials which do not belong to the proper point group to be used as collinear acousto-optic filters can nevertheless be used in a "noncollinear" filter configuration; ³⁴ with somewhat greater restrictions on the acceptance angle. Sue high acousto-optic figures of merit of Tl₃AsS₄ and other new and promising sulfosalt single crystals such as Tl₃PSe₄ and Tl₃AsSe₄ will make them very useful in such noncollinear accusto-optic filter applications, even though they do not possess the proper symmetry to be used in the collinear configuration.

9. CONCLUSIONS

Two important conclusions have been reached on the basis of work performed during this program. These are as follows.

- 1. Phase diagram studies are essential to understand observed features of the crystal growth of complicated ternary compounds such as the T1-As-S-Se compounds investigated during this contract. We have demonstrated that dramatically improved crystal quality results from systematic phase diagram studies conducted within the context of crystal growth.
- 2. The ternary compounds in Tl-As-S and Tl-As-Se chemical systems represent a class of compounds that show considerable potential as single-crystal materials for optical and acousto-optical devices. The work performed during this contract represents an essential foundation for future studies of these materials in devices.

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